



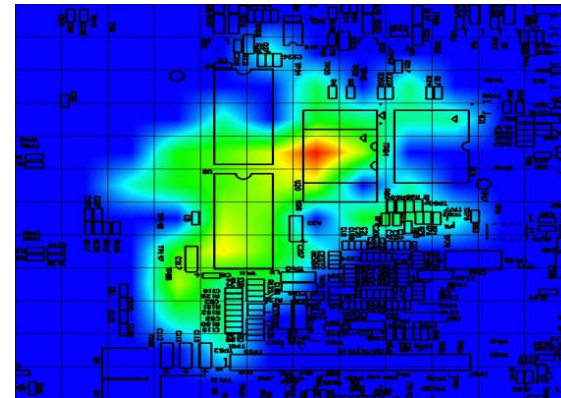
**Very-Near-Field Solutions
for
Antenna Measurement Problems**



Chamber on your Desktop

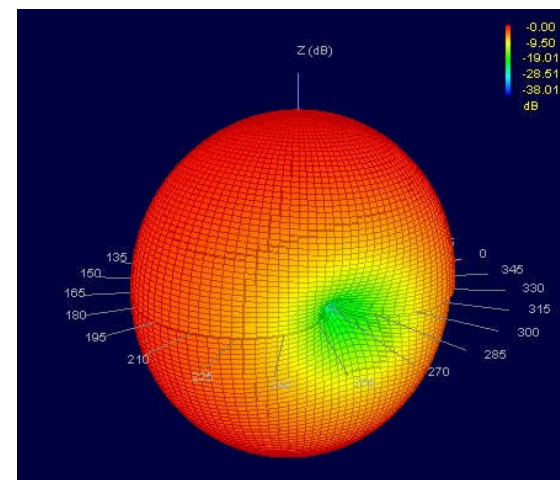
- **EMxpert**

- EMC diagnostic tool to rapidly diagnose and solve EMC/EMS/EMI problems with real-time PCB emission analysis



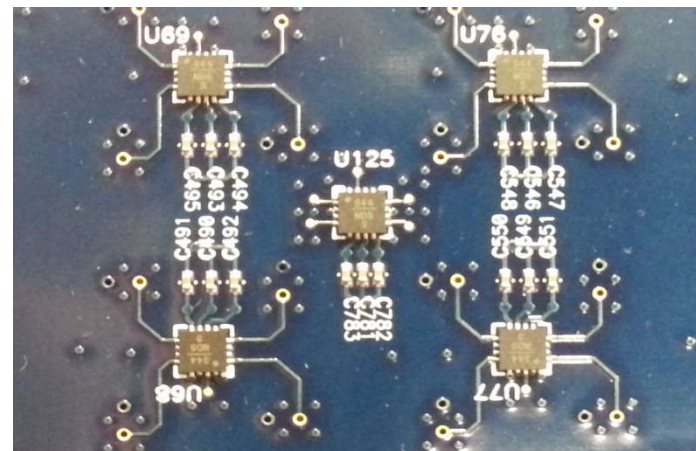
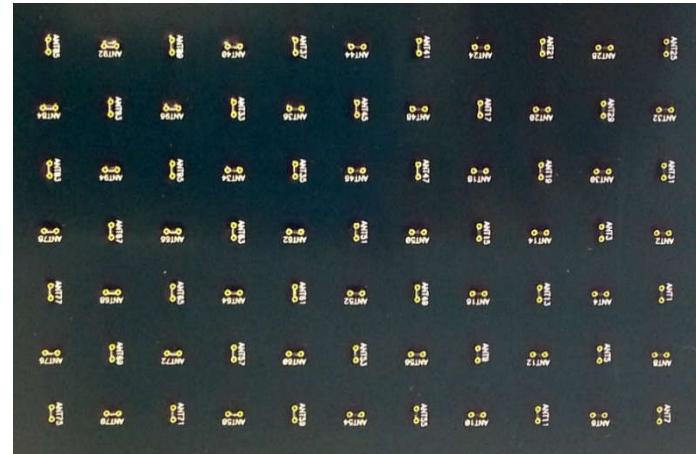
- **RFxpert**

- APM tool enabling to quickly evaluate performance and optimize designs with real-time antenna performance characterization



Fundamentals

- High-density planar antenna array
- High-speed electronic switching
- Very-near-field measurements
- Far-field calculation
- “Real-time” real-fast
- No chamber



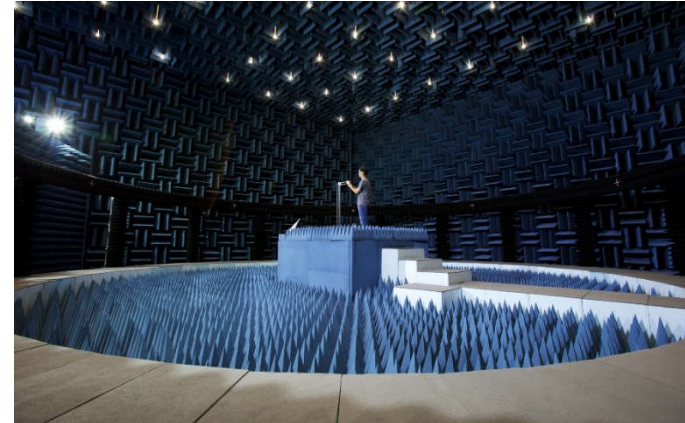
RFxpert

Introduction to Near-Field Theory

Existing Solutions

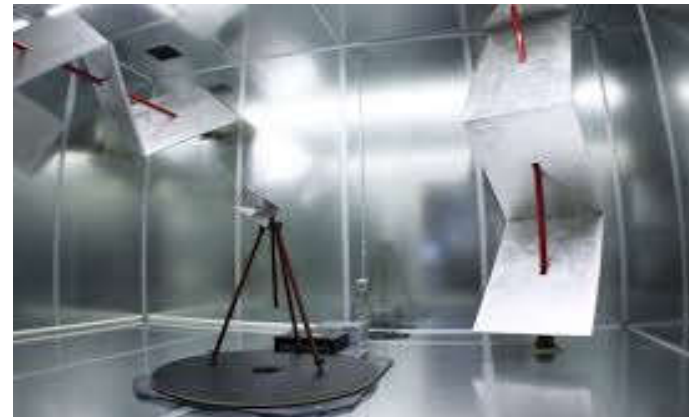
- **Anechoic Chamber**

- Slow testing
- High CAPEX and OPEX
- Real-estate
- Qualified personnel



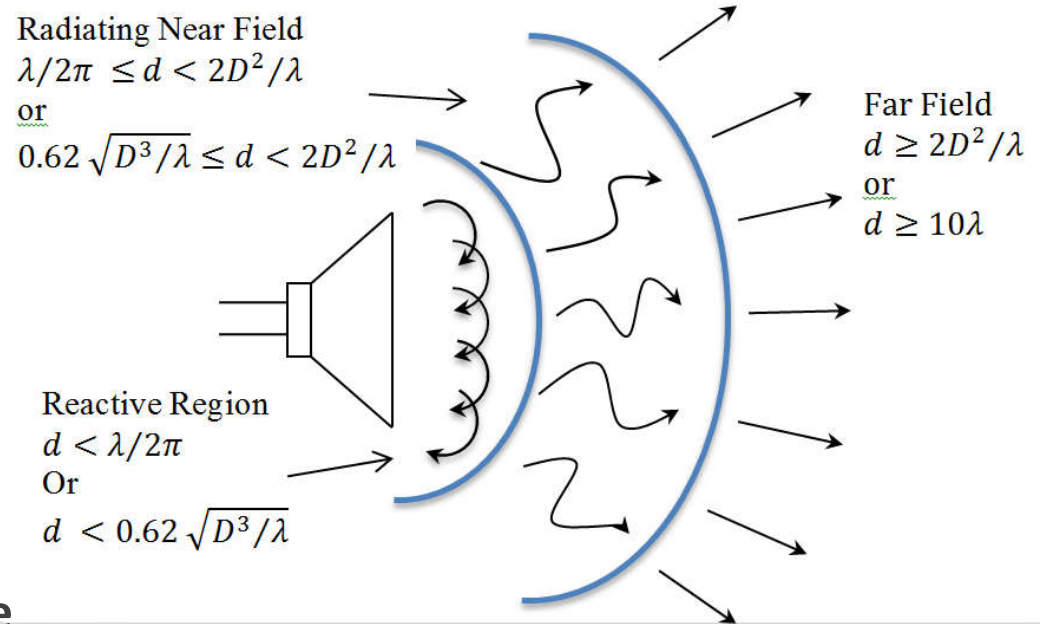
- **Reverberation Chamber**

- Fast testing
- No pattern
- Qualified personnel



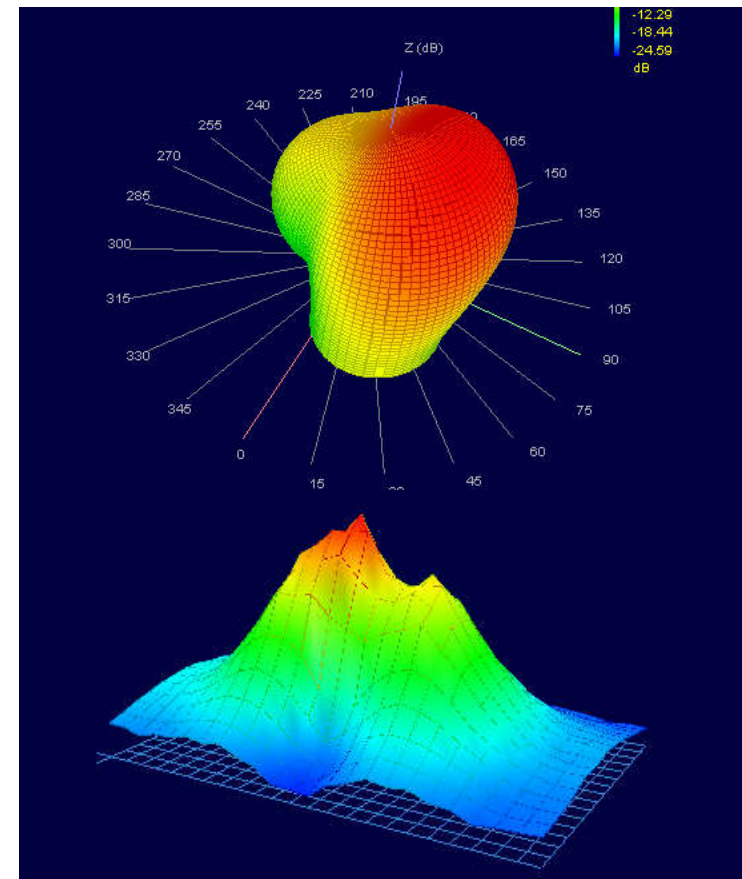
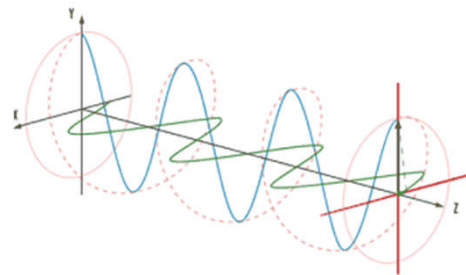
What is Near-Field?

- Anything not in the far-field
- Far-field is where the pattern is not changing with the distance
- Common definitions
- Usually stay out of the reactive region



Functionality

- 300 MHz to 6.0 GHz
- Far-field patterns and bisections
 - EIRP / TRP / TIS Proxy
 - Circular and linear polarization
- Very-near-field insights
 - Amplitude
 - Phase
 - Polarity
- Gain and efficiency
- DLL programming

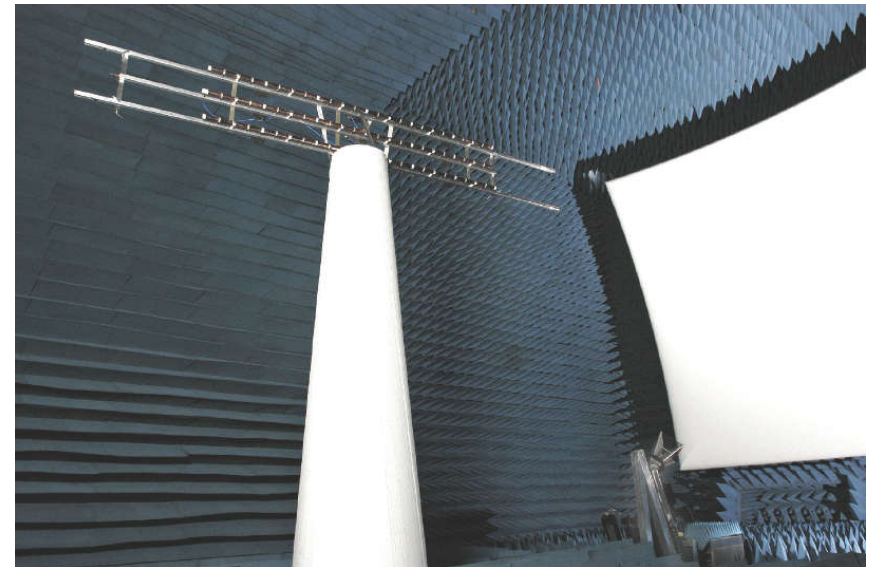


RF Test Solution

- **Typically looking for far-field parameters**
 - Gain, efficiency, pattern are basic measures
 - More complex applications such as Envelope Correlation, Axial Ratio and Beam Forming
- **Debugging via near-field**

Far-Field Measurements

- **Far-field site far and demanding a large area**
- **Open-air-test-site (OATS) avoids reflections**
 - Almost impossible in an urban environment
- **Anechoic Chambers**



Near-Field to Far-Field Transformation

- **Near-field measurement**
 - Smaller footprint
 - Can be as accurate as far-field

- **Near to Far projections**
 - Plane Wave/Modal Expansion
 - Magnetic currents
 - Genetic algorithms and more

Planar Near-Field Theory

- The radiation of the antenna can be described in terms of angular spectrum of waves
- Based on Huygen's principle
- Fourier transform from near-field space to propagation vectors in far-field

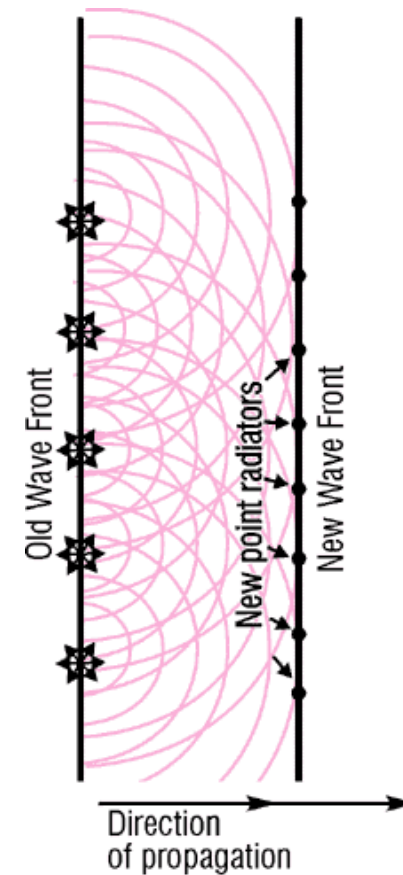
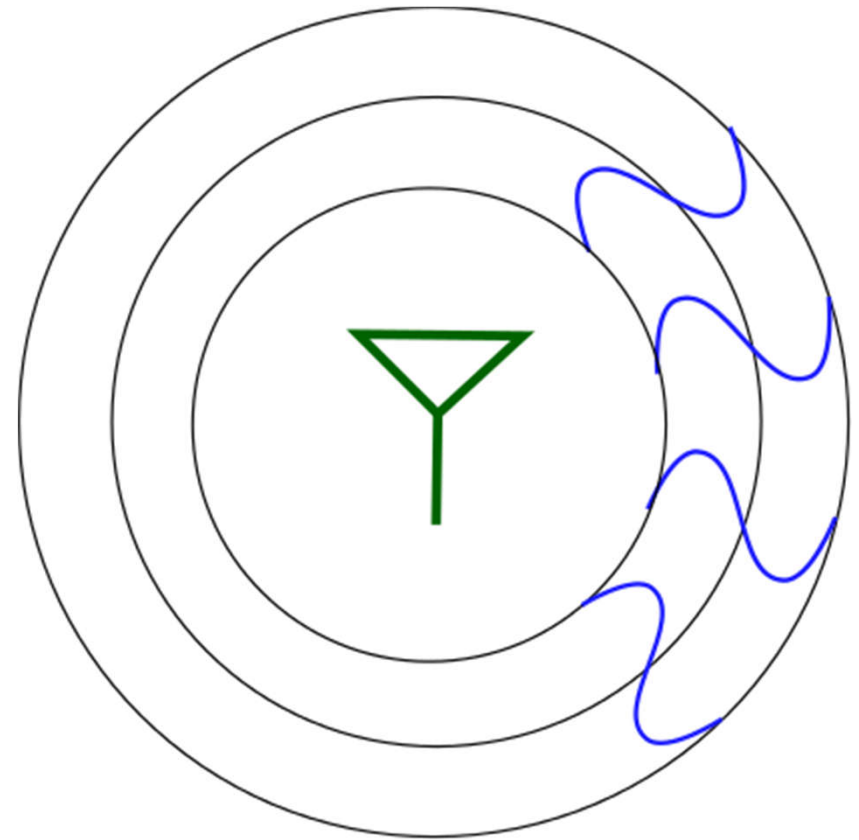


Image: www.schoolphysics.co.uk

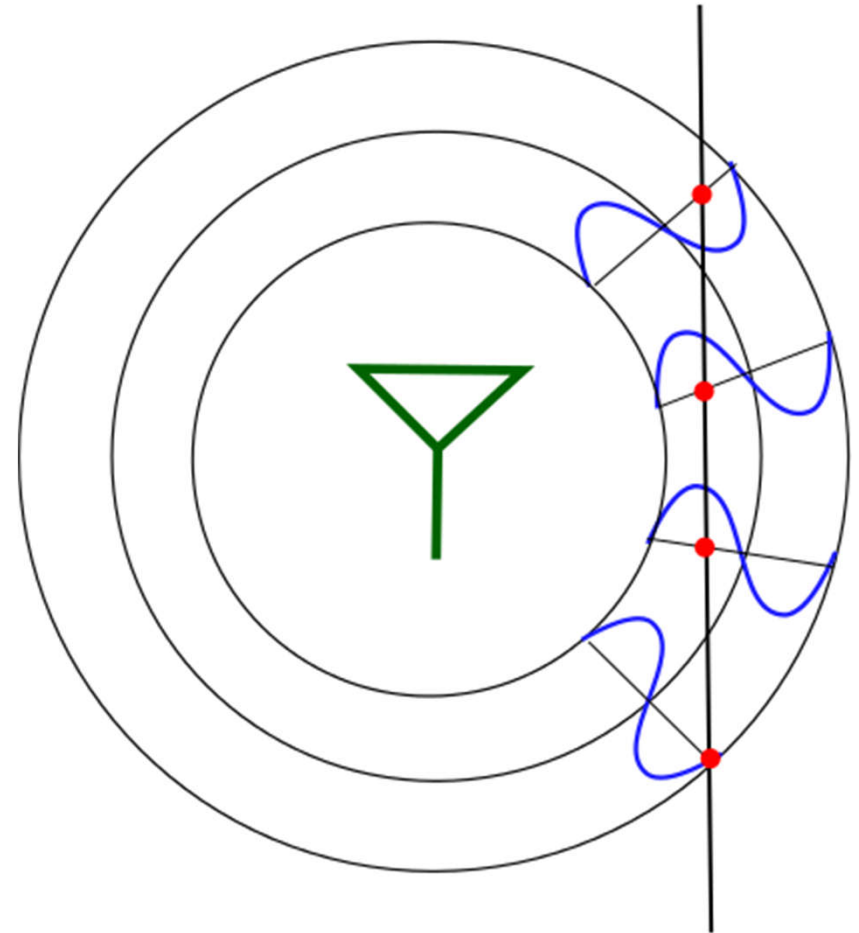
Planar Near-Field Theory

- An antenna can propagate in all directions
- The phases and amplitudes in each directions will vary
- In the near field all elements are interdependent



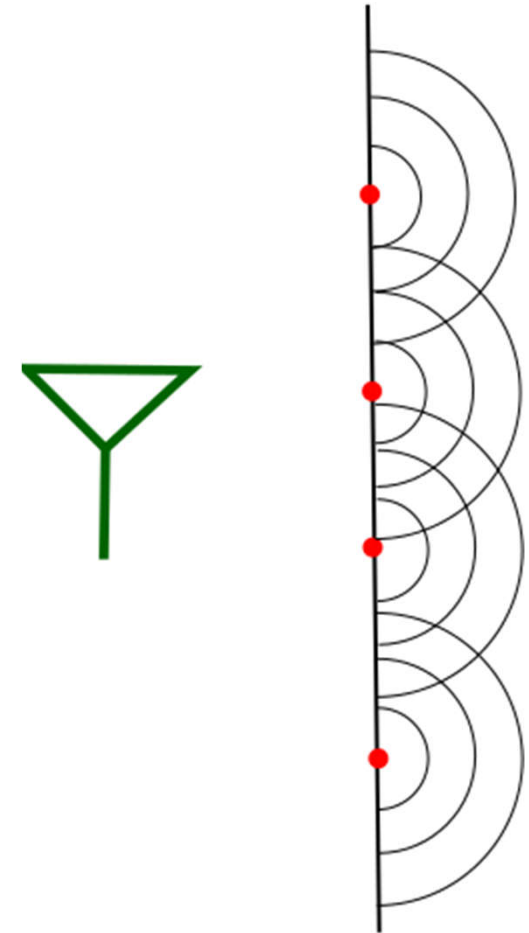
Planar Near-Field Theory

- Sample near field elements along a planar surface
- Measure amplitude and phase in each point
- Combination of phase fronts



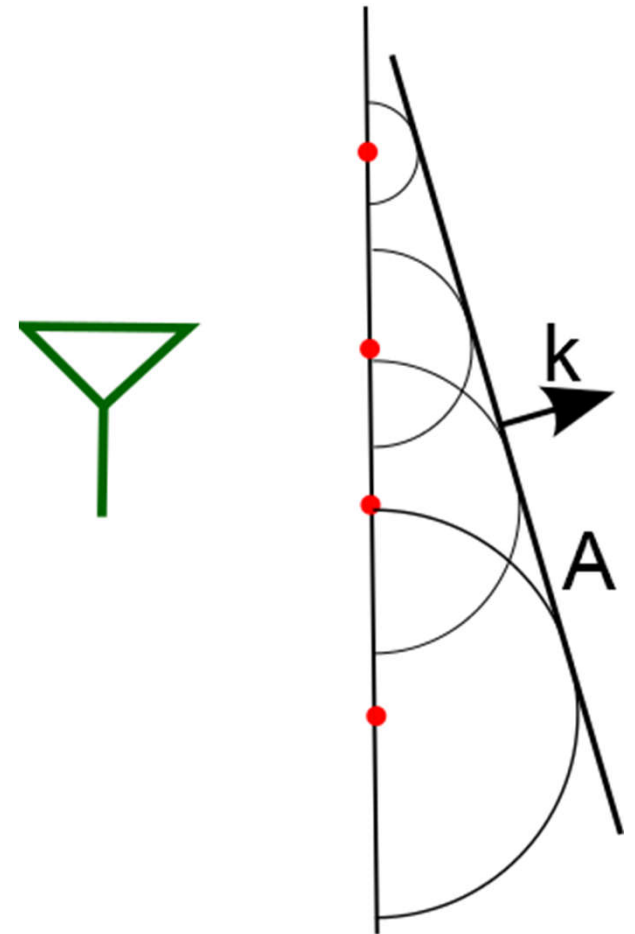
Planar Near-Field Theory

- Use sampled points to reconstruct new phase fronts
- No difference between this and the original phase front that was sampled



Planar Near-Field Theory

- Separate the various phase fronts or plane waves based on their weightings
- This set of plane waves in all directions is the plane wave spectrum



Planar Near-Field Theory

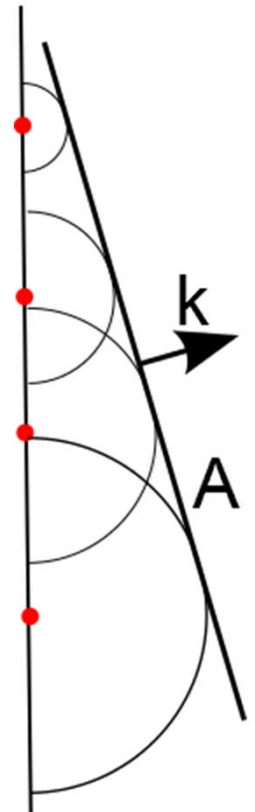
Based on Maxwell's equations and a source-less boundary condition we can construct the following equations

$$\mathbf{E}(x, y, z) = \frac{1}{2\pi} \int_{-\infty}^{+\infty} \int_{-\infty}^{+\infty} \mathbf{A}(k_x, k_y) e^{-j\mathbf{k}\cdot\mathbf{r}} dk_x dk_y$$

$$\mathbf{H}(x, y, z) = \frac{1}{2\pi} \int_{-\infty}^{+\infty} \int_{-\infty}^{+\infty} \mathbf{k} \times \mathbf{A}(k_x, k_y) e^{-j\mathbf{k}\cdot\mathbf{r}} dk_x dk_y$$

The term \mathbf{k} may be called the wave number vector and the terms in the integration represent a uniform plane wave propagating in the \mathbf{k} direction

$$\mathbf{A}(k_x, k_y) e^{-j\mathbf{k}\cdot\mathbf{r}}$$

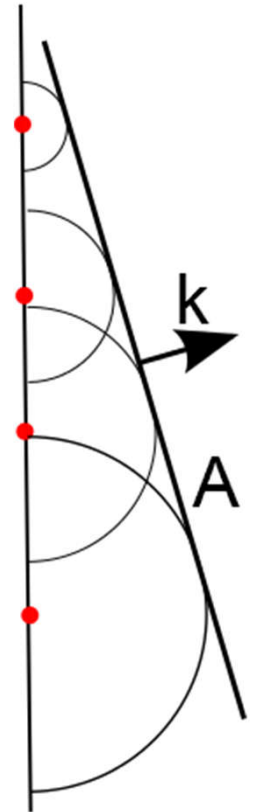


Planar Near-Field Theory

And $\mathbf{A}(k_x, k_y)$ can be determined by ,

$$A_x(k_x, k_y) = e^{jk_z z_t} \frac{1}{2\pi} \int_{-\infty}^{+\infty} \int_{-\infty}^{+\infty} E_x(x, y, z_t) e^{j(k_x x + k_y y)} dx dy$$

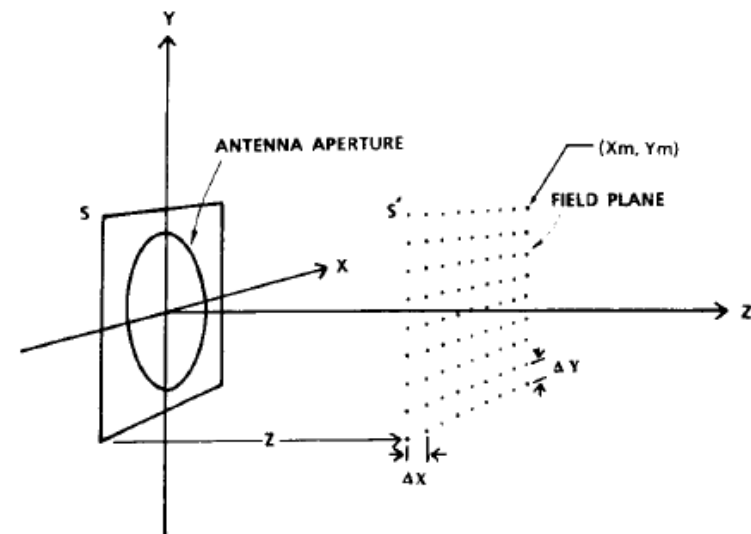
$$A_y(k_x, k_y) = e^{jk_z z_t} \frac{1}{2\pi} \int_{-\infty}^{+\infty} \int_{-\infty}^{+\infty} E_y(x, y, z_t) e^{j(k_x x + k_y y)} dx dy$$



Planar Near-Field Benefits

$$\mathbf{E}(x, y, z) = \frac{je^{-jkr}}{r} k_z \mathbf{A}(k_x, k_y)$$

- Simple Fourier transform
- Easy to calculate quickly
- Easy to sample data

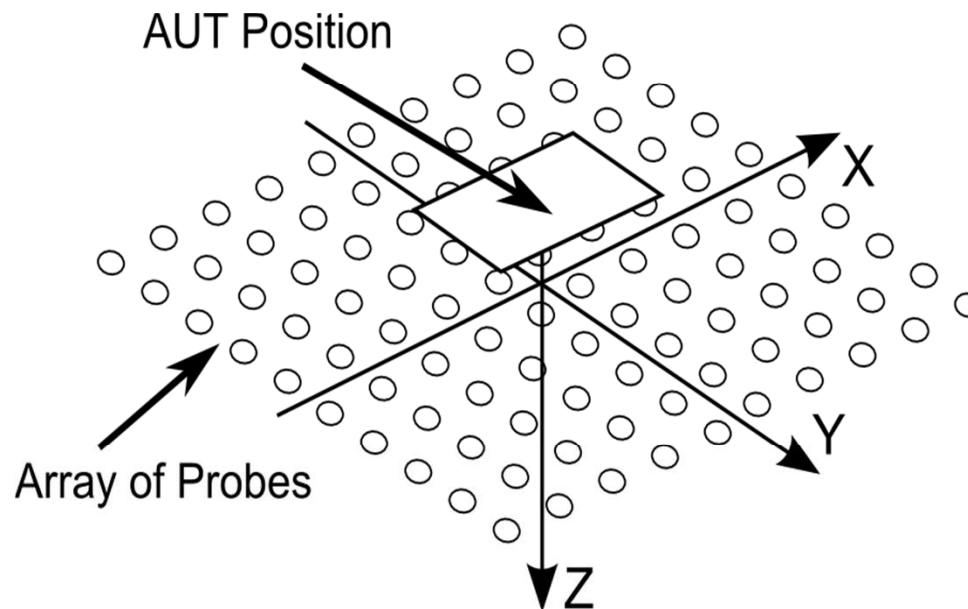


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A Very-Near-Field Implementation

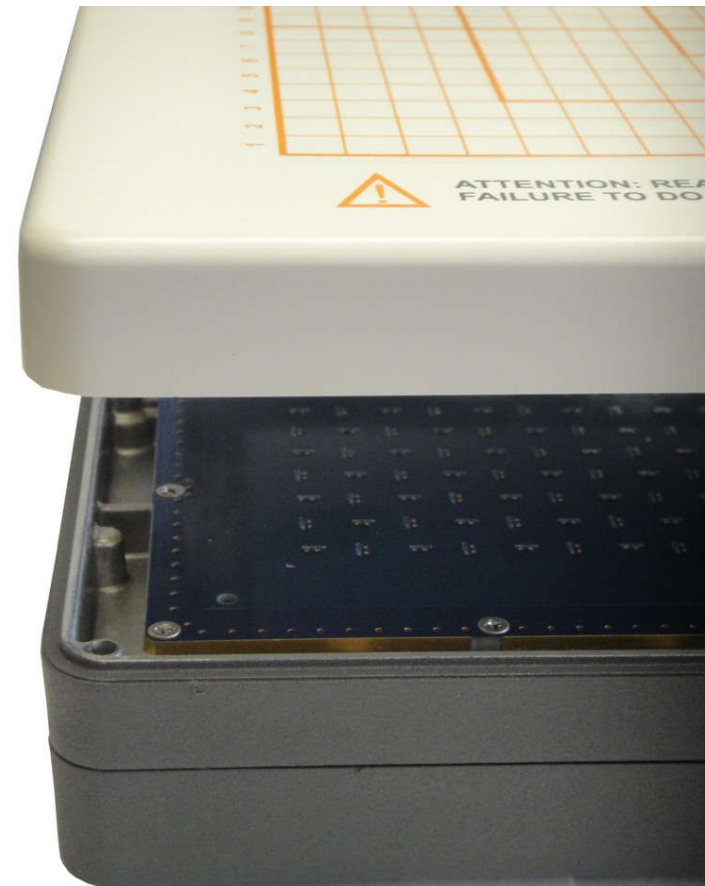
Very-Near-Field Challenges

- Coupling unavoidable so make it predictable
- Static array has constant effect for each sample

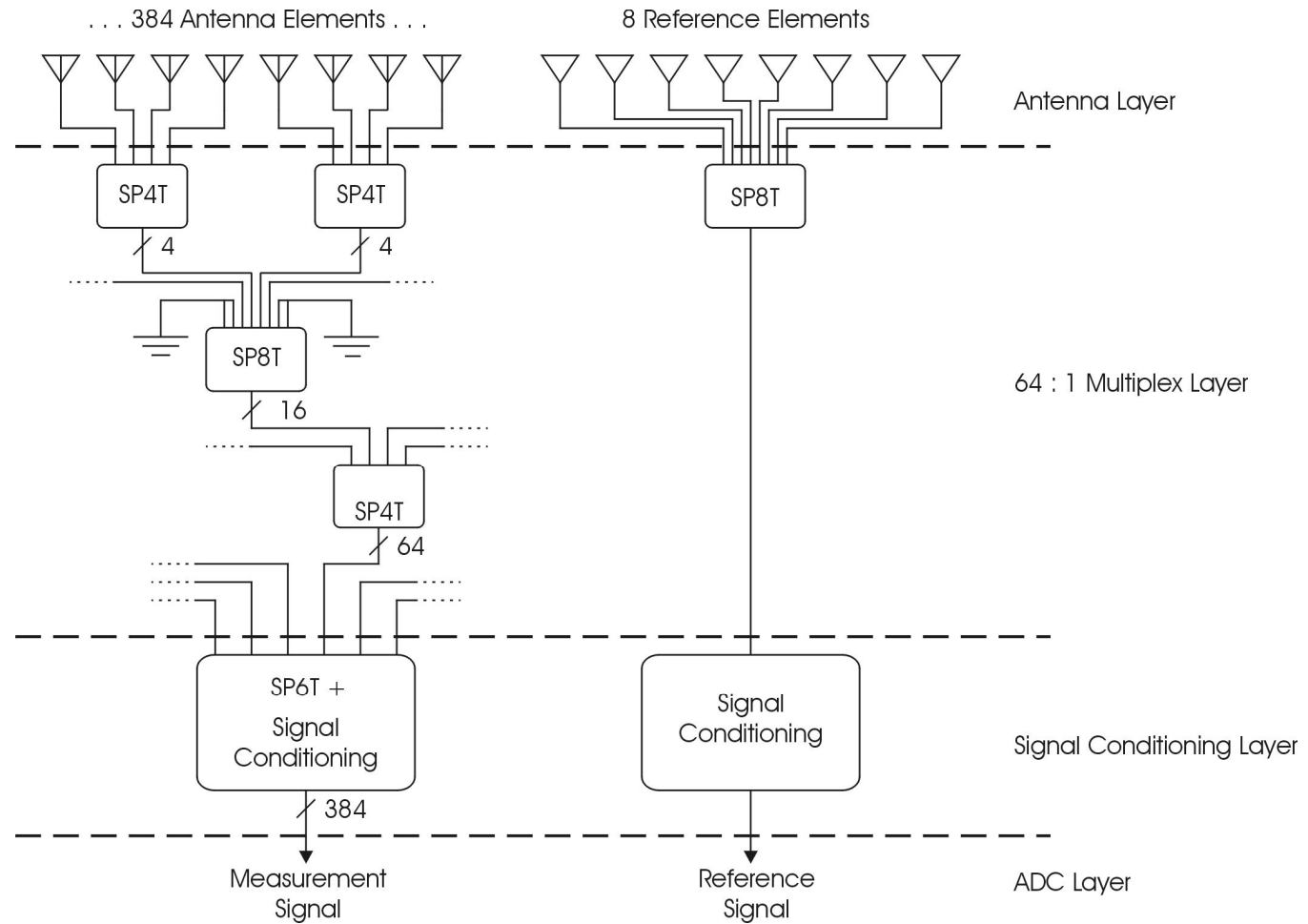


Very-Near-Field Implementation

- **Array of probes**
- **Addressable array of probes makes very-near-field sampling very fast and repeatable**
- **Small loops not sensitive but very broadband, with good isolation and polarization specifications**
- **Reference channel for phase measurement of active devices**

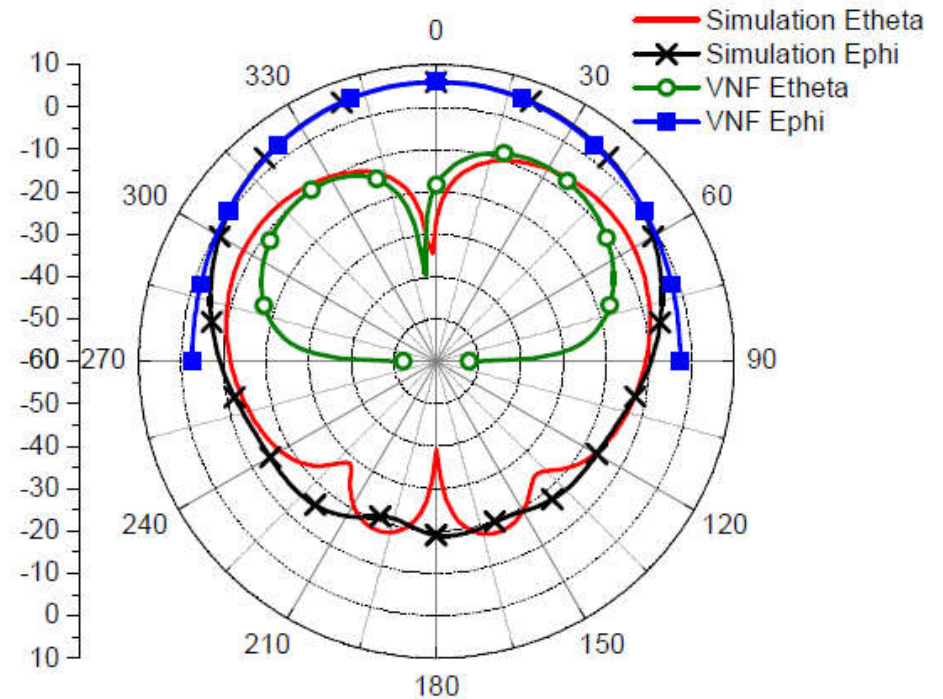


Very-Near-Field Implementation



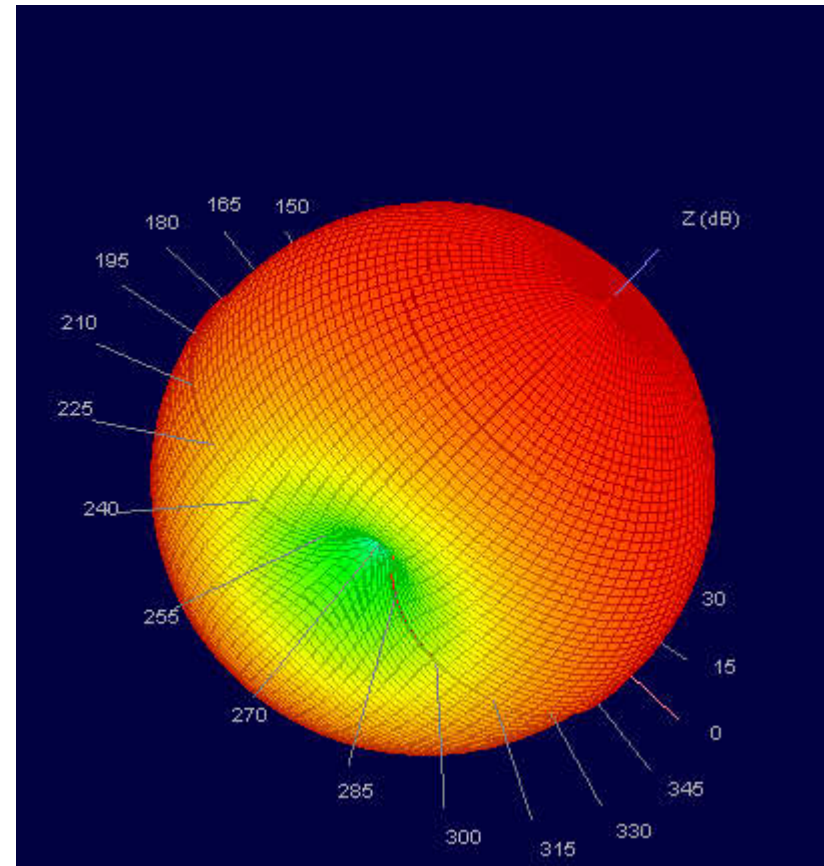
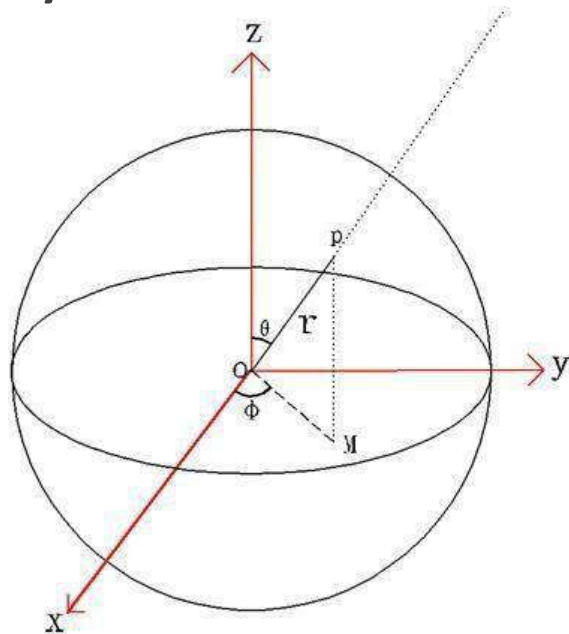
Results with Ideal Data

- Still have limitations of finite planar scans
- Hemispherical results
- Limited angular coverage
- E-theta always reduces to zero at horizon



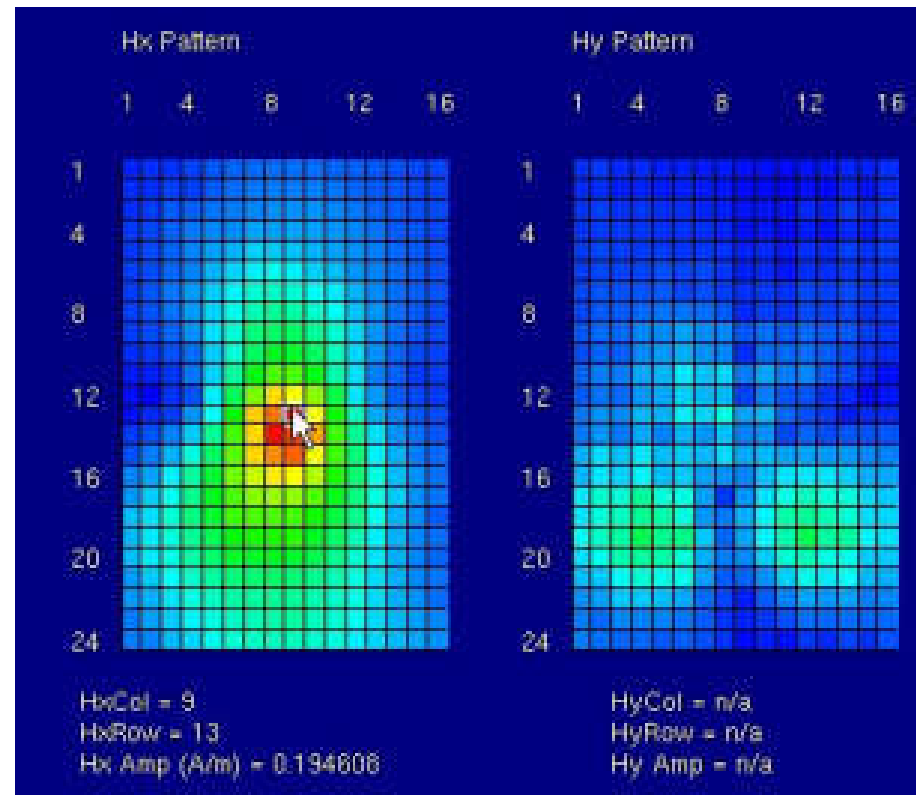
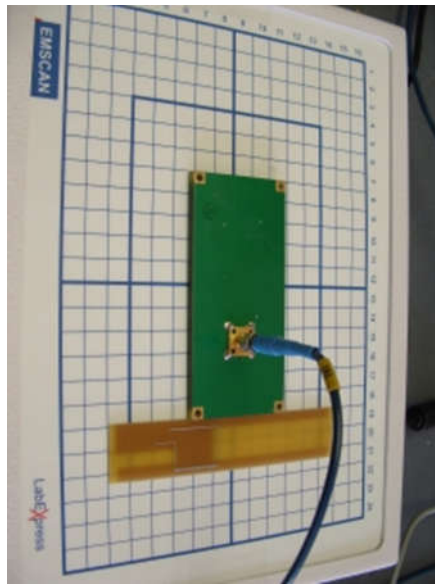
Aggregate Node

- Combined scan results for full spherical far-field view
- User defined elevation for asymmetrical devices



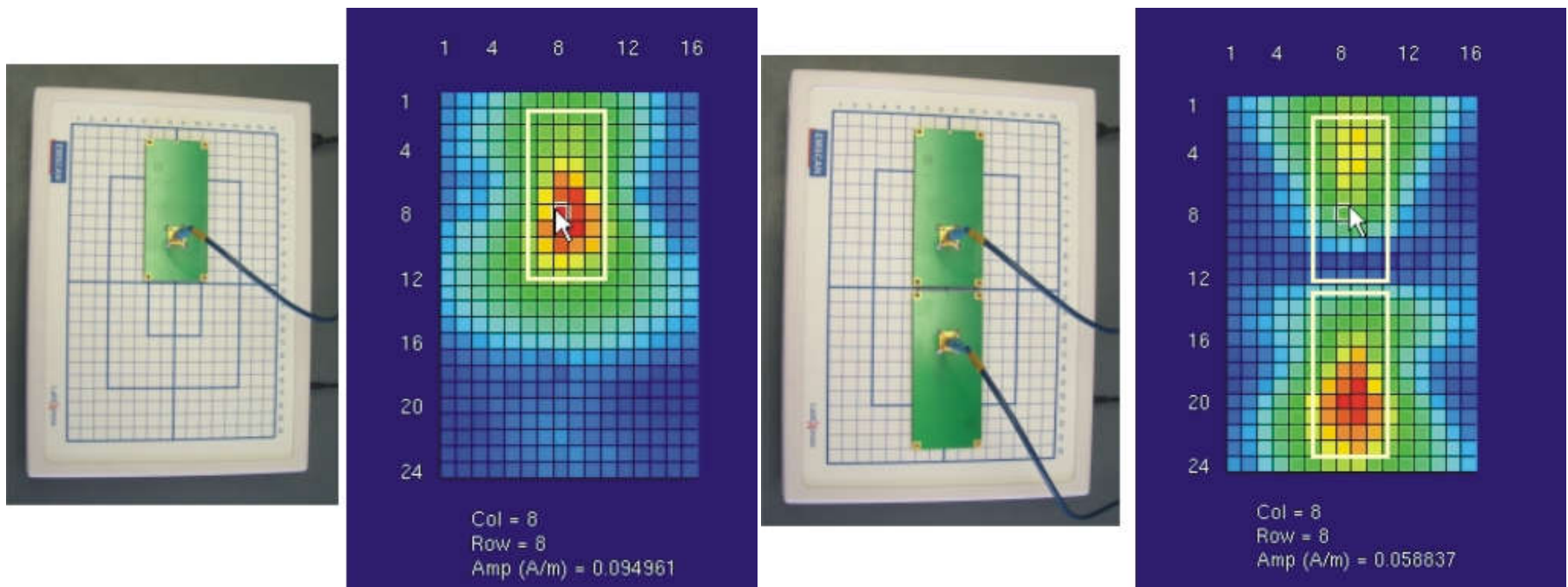
Very-Near-Field Benefits

- Visualizing interference in the near-field
 - Resonance and mutual coupling



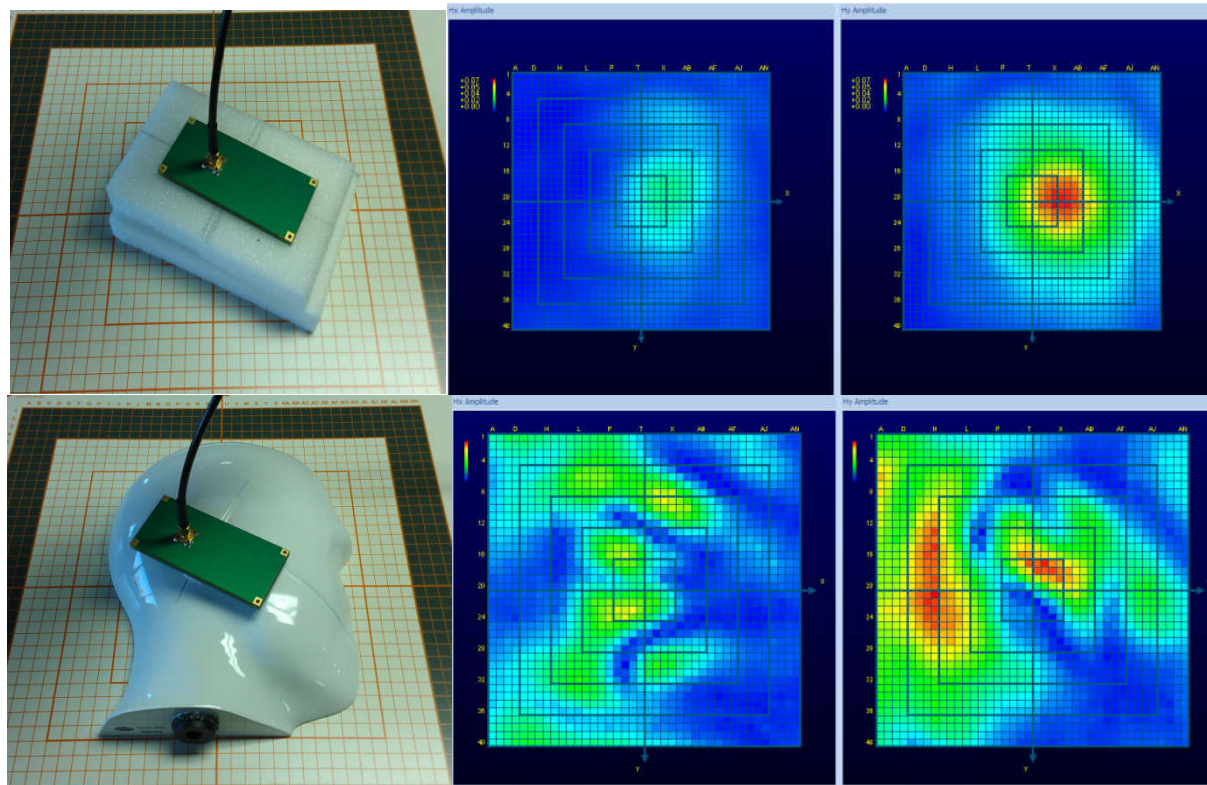
Very-Near-Field Benefits

- Antenna position
- Loading and field perturbation



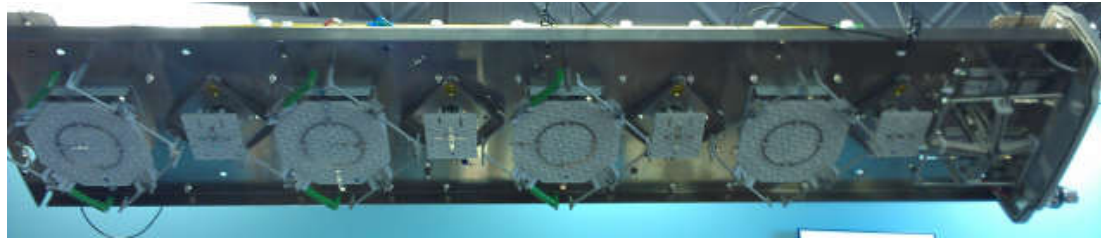
Very-Near-Field Benefits

- Effects of Surrounding Material

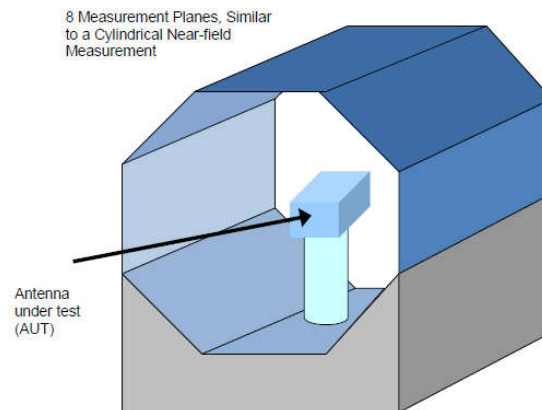


Aggregated Very-Near-Field

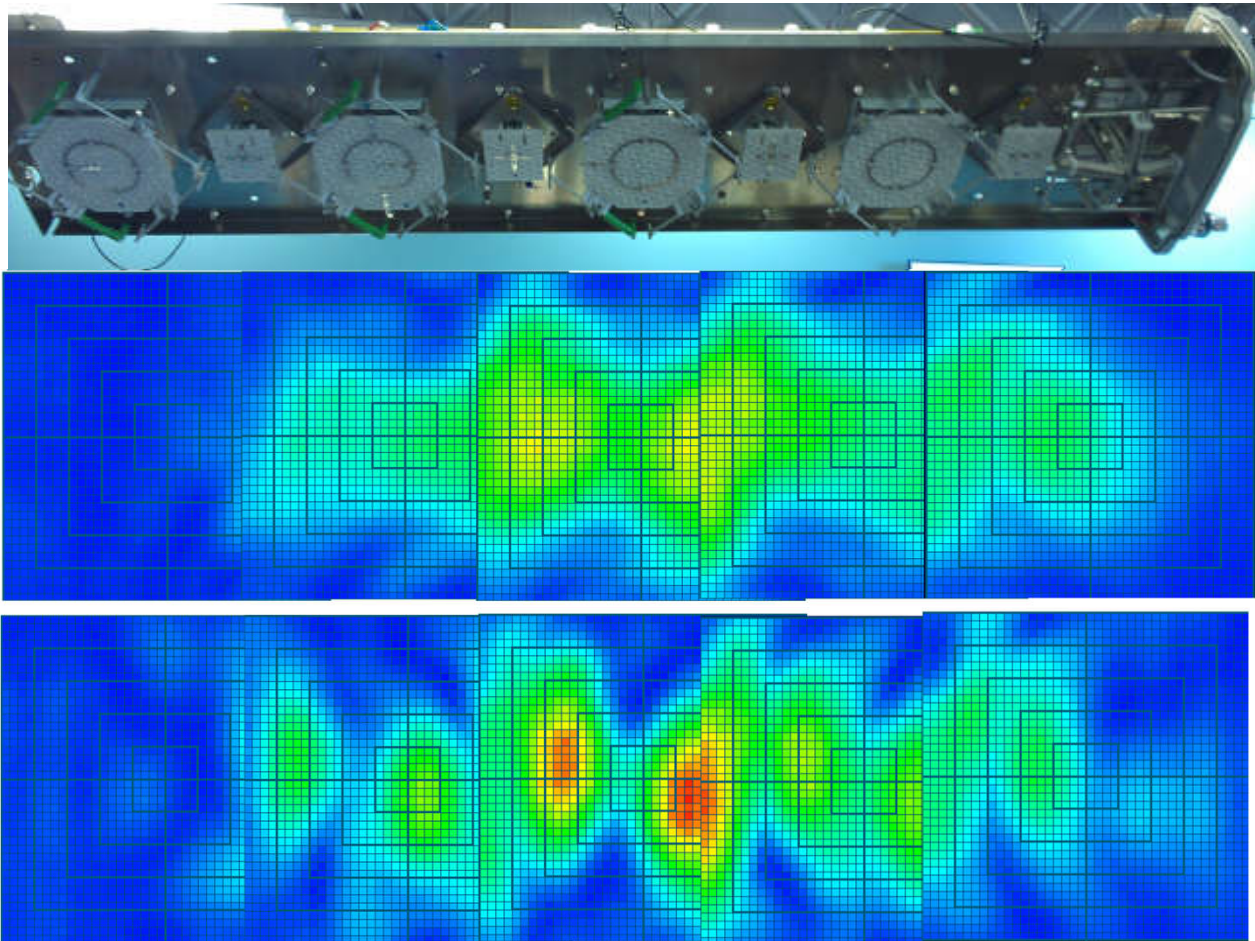
- Multiple planar measurements combined together to provide larger effective scan area



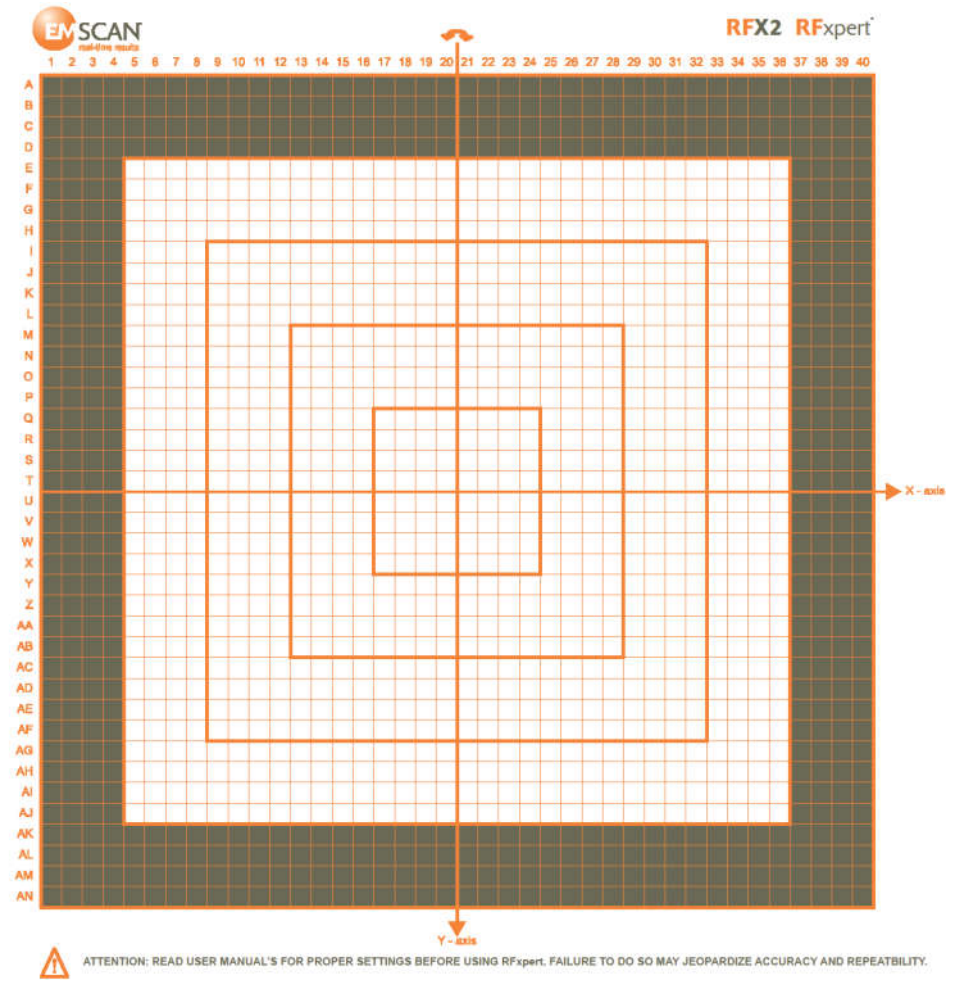
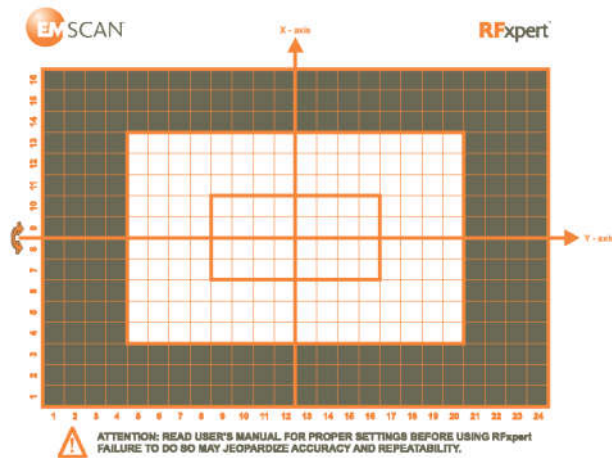
- Multiple planar scans do not need to be co-planar
 - Can used to created 3D scan surfaces or even enclosed surfaces



Aggregated Very-Near-Field

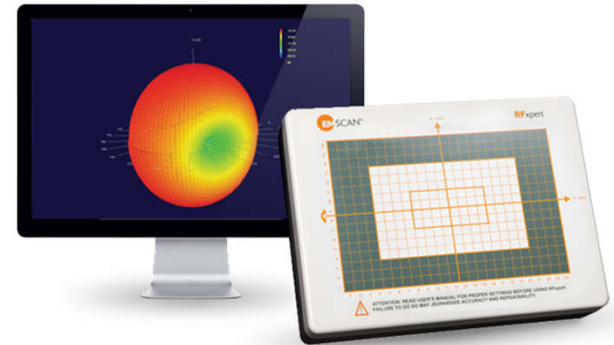


RFX and RFX2



RFxpert

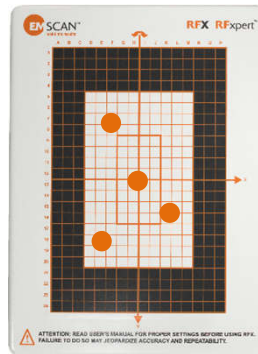
- **Fast measurements**
 - Continuous “real-time”
 - Single scan < 1 second
- **Compact tabletop instrument**
- **Cost effective solution**
- **Easy-to-use by any engineer**



High Accuracy

- **Repeatability**

- +/- 0.2 dB from one measurement to the next
- +/- 0.5 dB within the white test zone

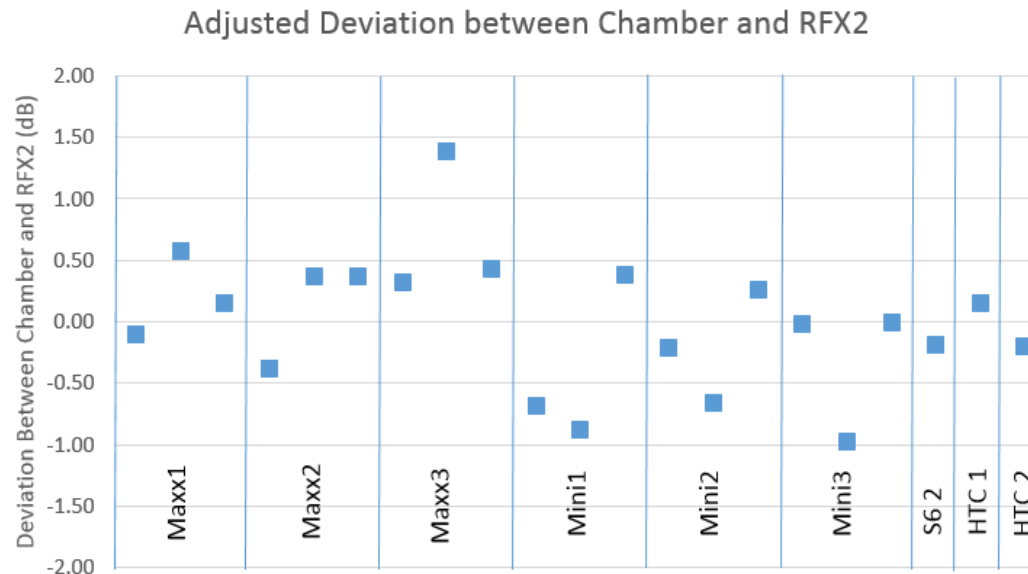


- **Relative accuracy**

- +/- 0.5 dB comparative measurements

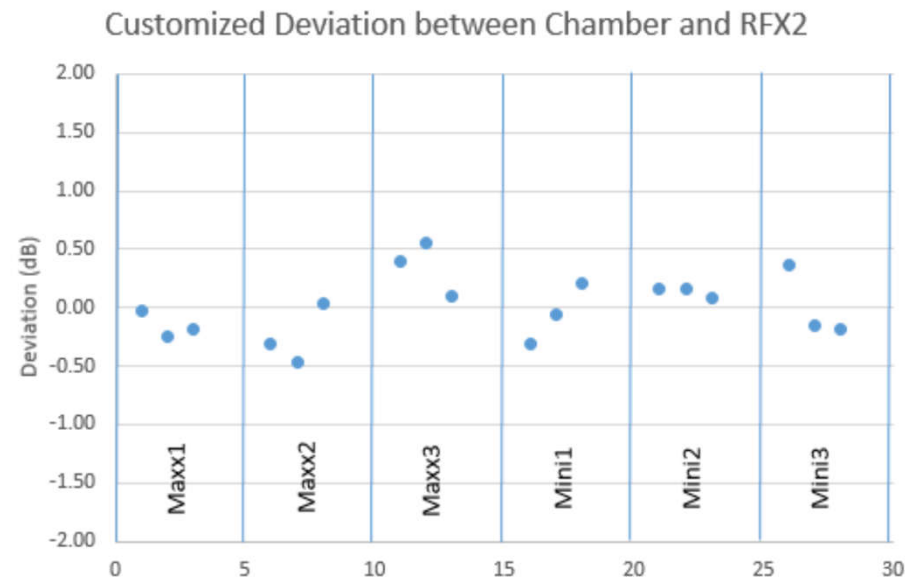
Absolute Accuracy Out-of-the-Box

- Aligned to the Atlanta CTIA Satimo chamber
- Re-align your RFXpert to your chamber
 - Portfolio of devices
 - $2\sigma = +/- 1.1$ dB at 700 MHz (better at higher frequency)



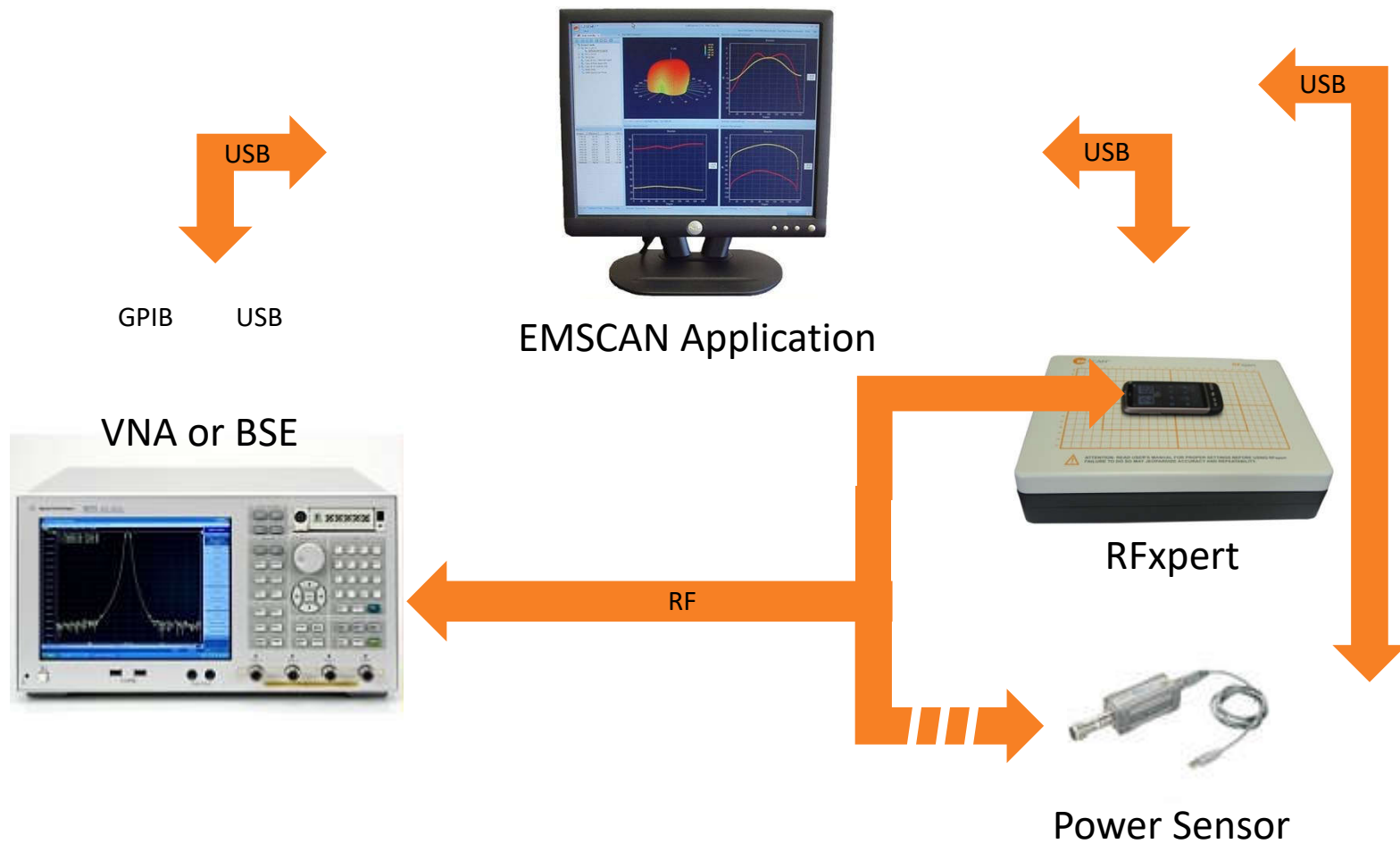
Absolute Accuracy Out-of-the-Box

- Aligned to the Atlanta CTIA Satimo chamber
- Re-align your RFXpert to your chamber
 - One device
 - $2\sigma = +/-0.54$ dB at 700 MHz



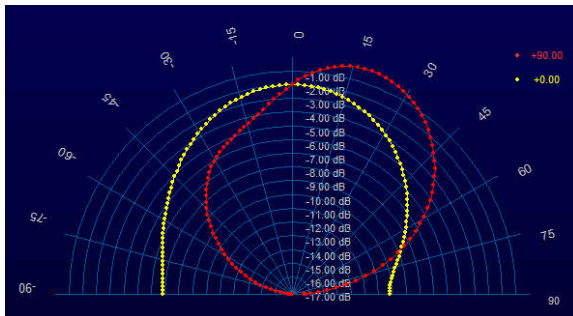
Technical Specifications

Configuration

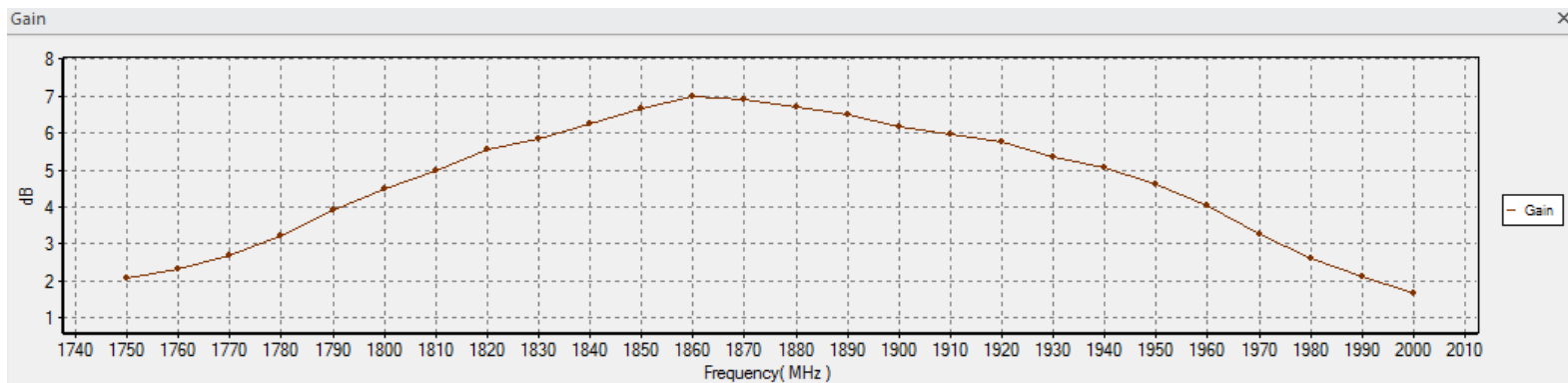


Frequency Scan

- Gain, efficiency, EIRP and TRP of a device at a discrete frequency and across a range of frequencies through remote control of a VNA

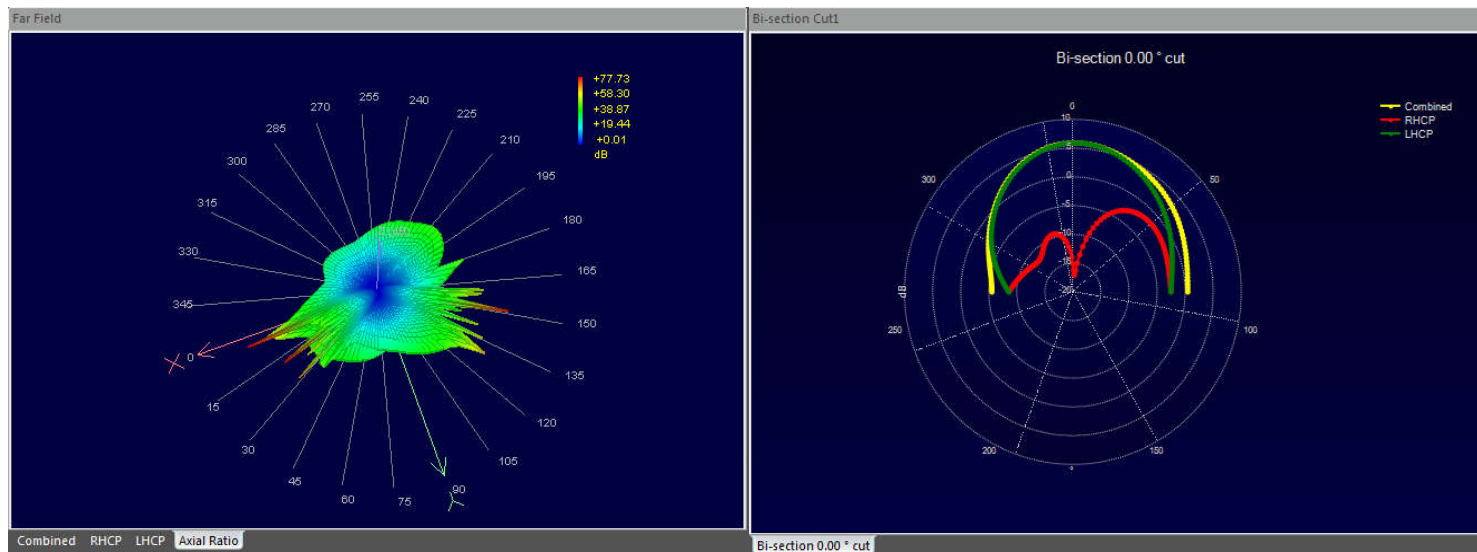


Frequency	Efficiency	Gain	EIRP
1880.00	73.91	6.66	6.66



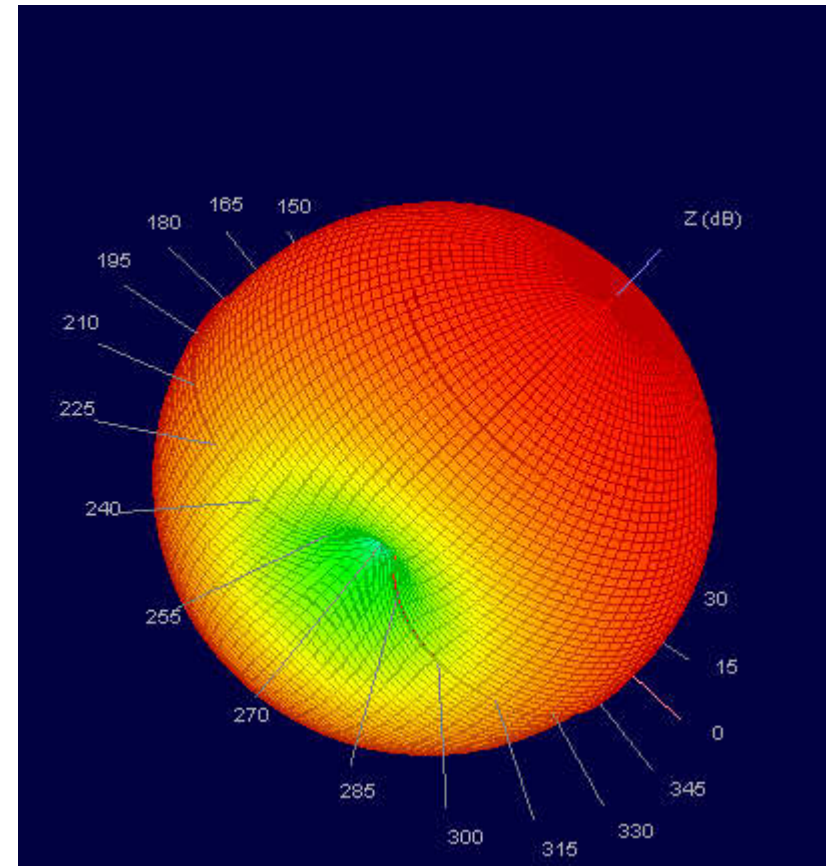
Circular Polarization

- LHCP / RHCP / AR over a range of $\pm 30^\circ$ from the center line



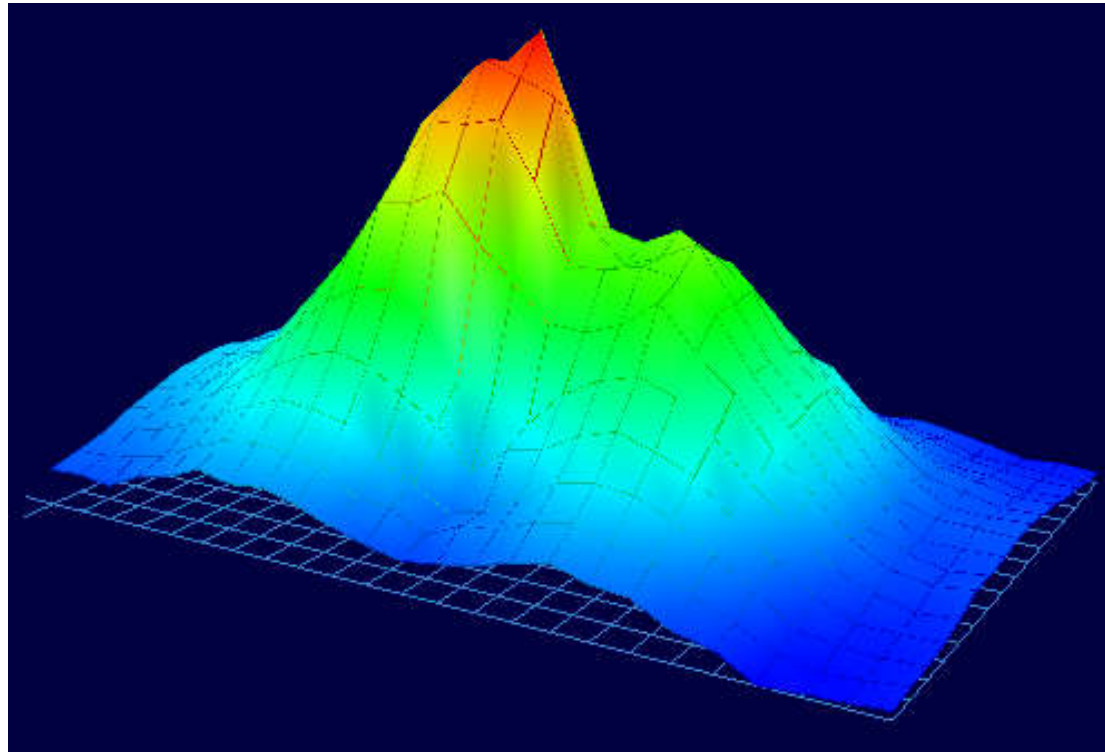
Aggregate Node

- Combined frequency scanning results for full spherical far-field view
- User defined elevation for asymmetrical devices



Very-Near-Field

- Insights into design issues



RFxpert

Comparison with Simulation

Simulation

Agilent EDA simulation

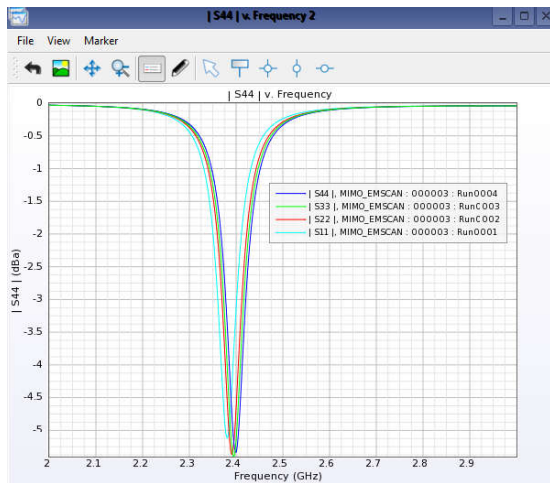
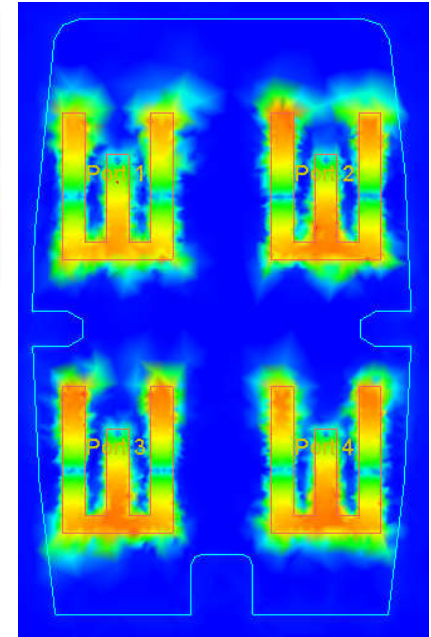
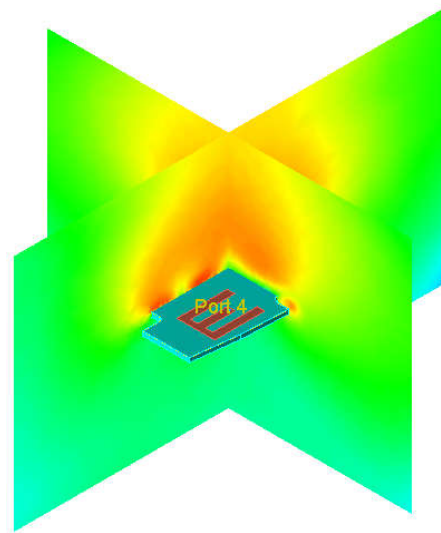
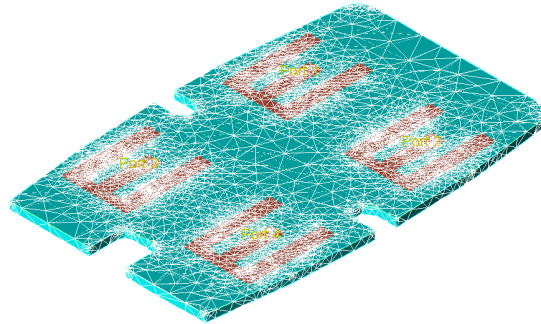
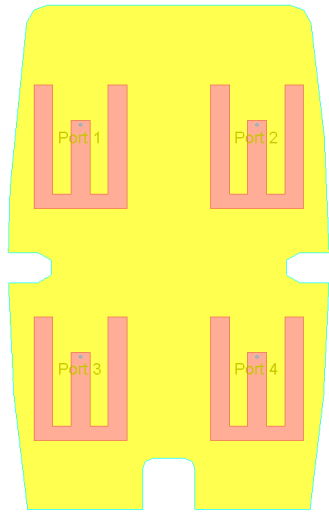
Toyo corporation (EMSCAN Representative)

Tokyo, Japan

June 19, 2012

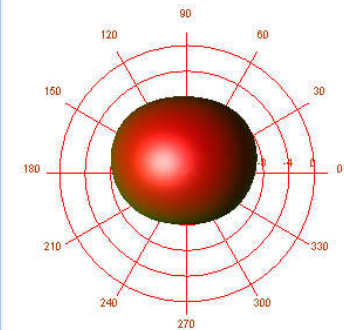
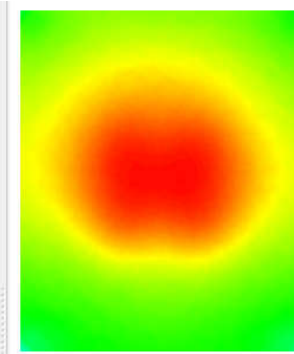


4 ブランチアンテナ



Multiple Mode Excitation

Port Weights		
	Weight	Phase
Source 1	1	0
Source 2	1	0
Source 3	1	0
Source 4	1	0



位相重みづけ

3cm上方磁界強度

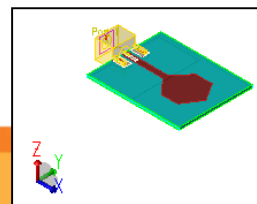
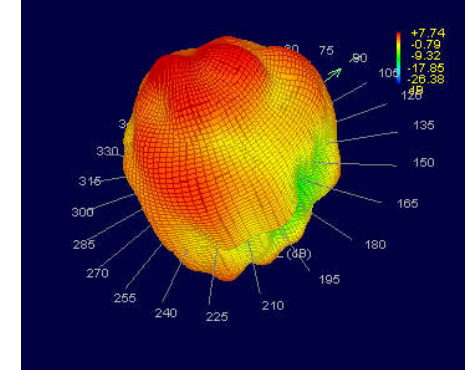
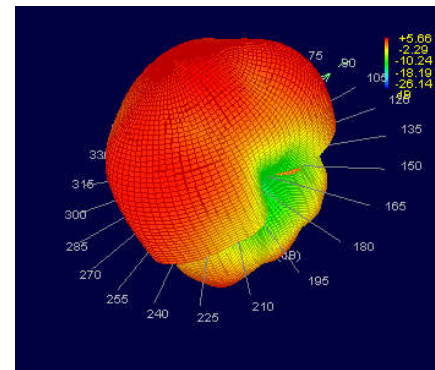
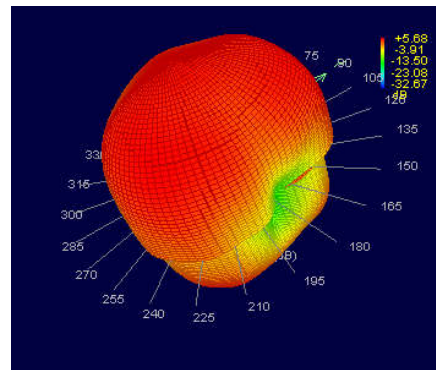
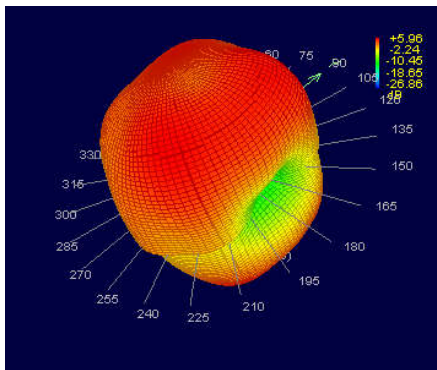
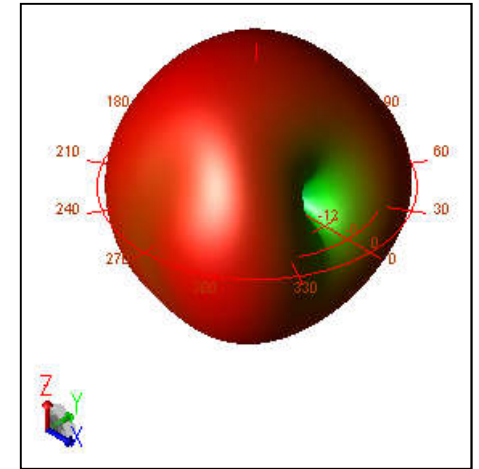
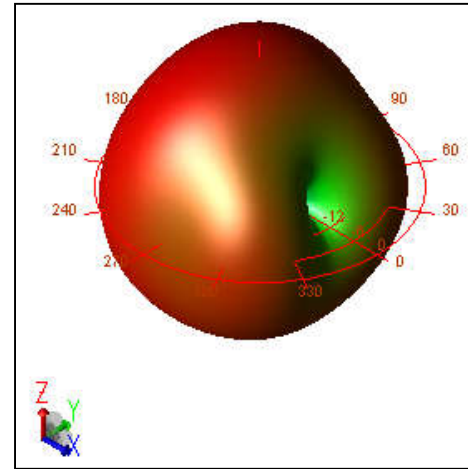
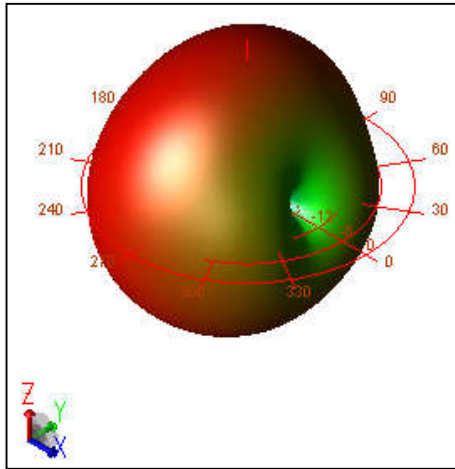
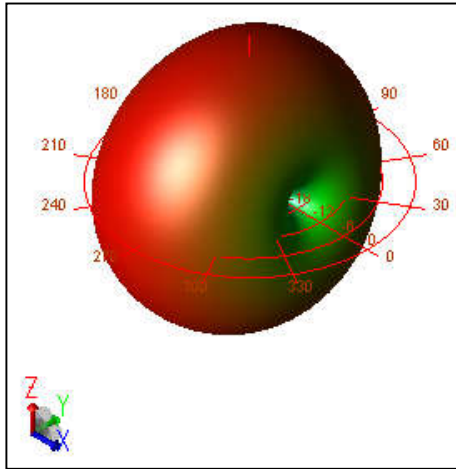
3D Farfield

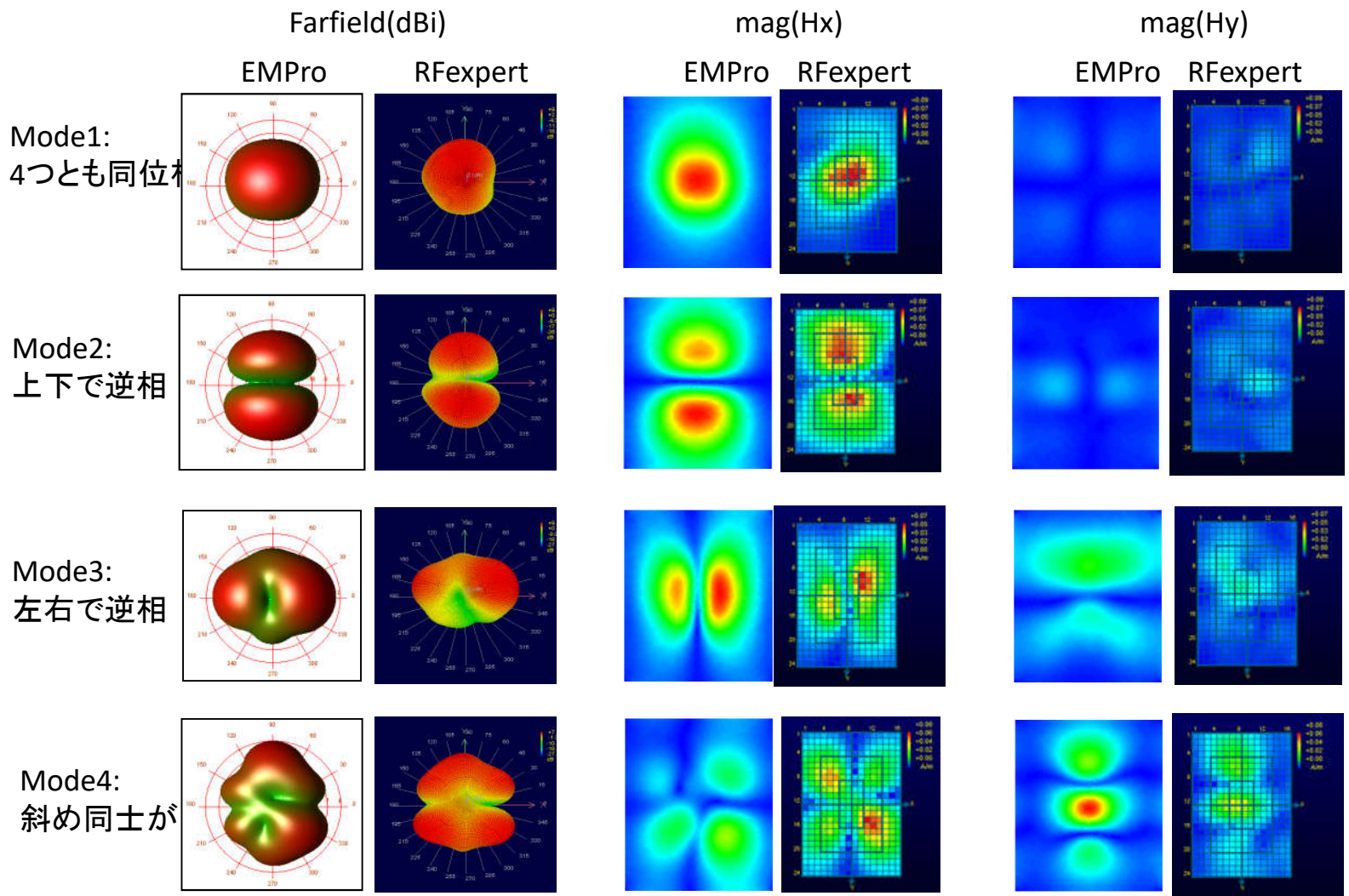
3GHz

4GHz

5GHz

6GHz

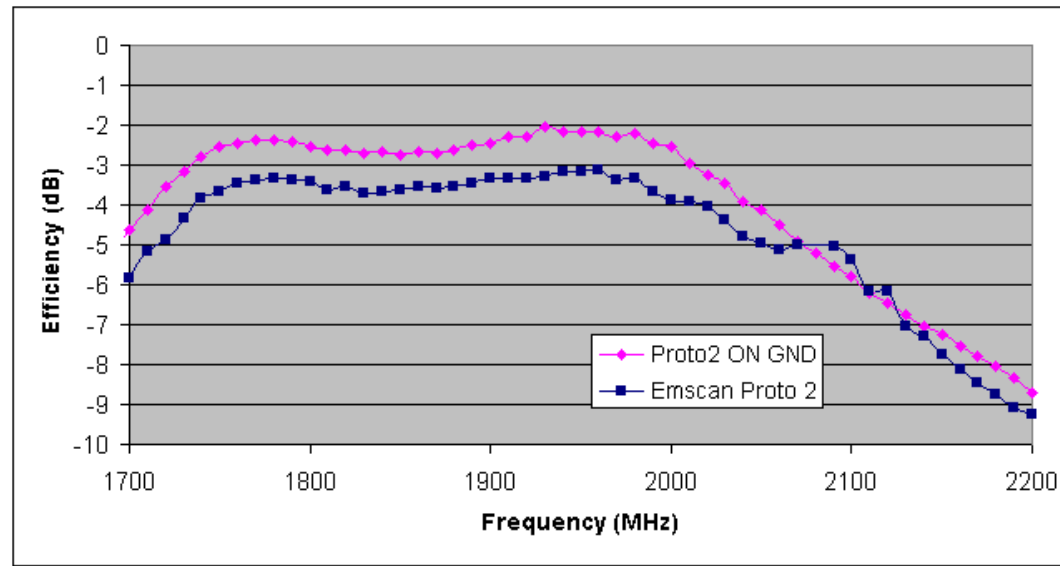
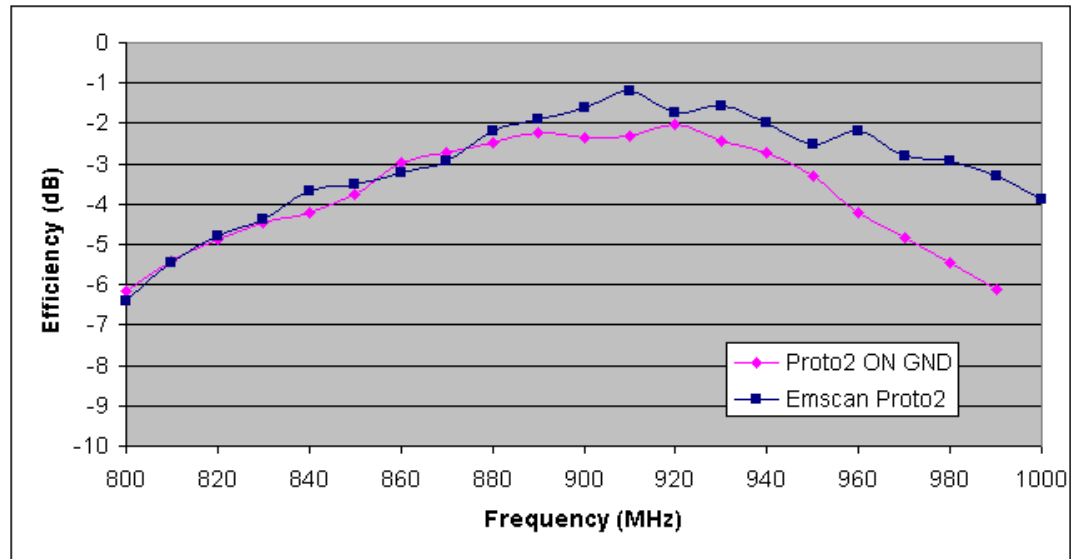




RFxpert

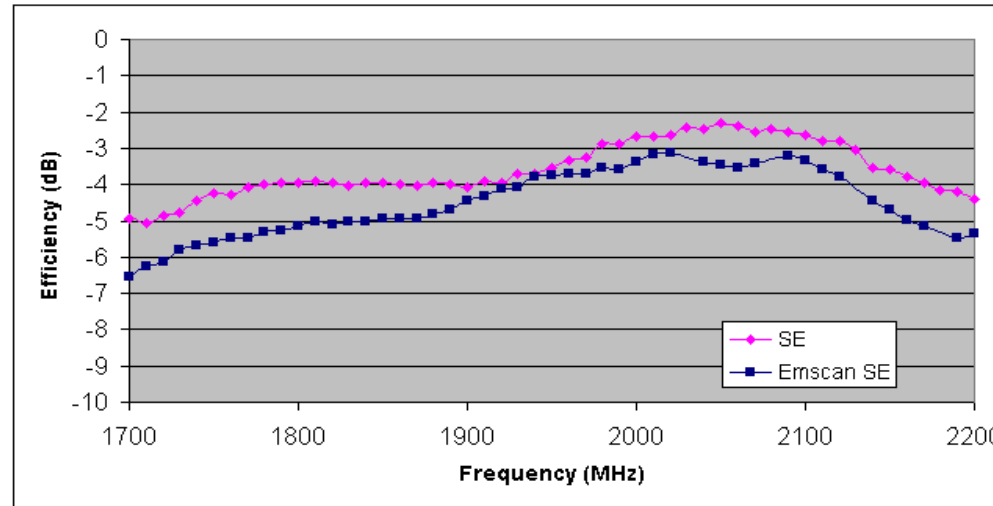
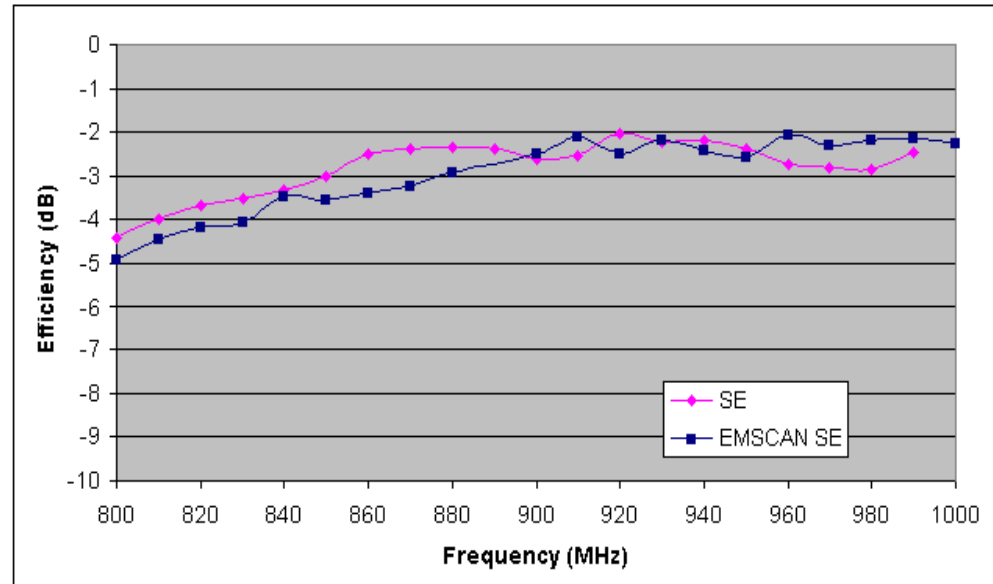
Comparison with Chamber Results

Mobile Phone Efficiency



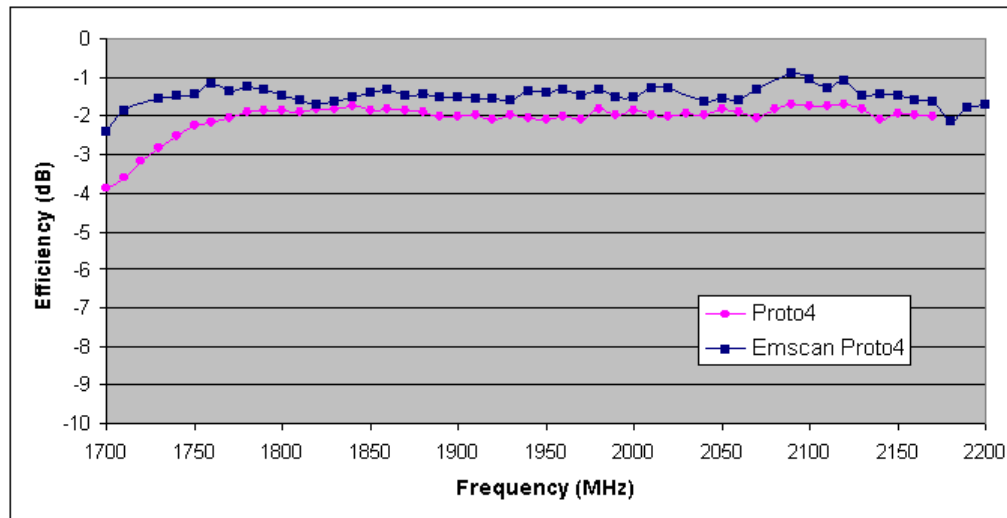
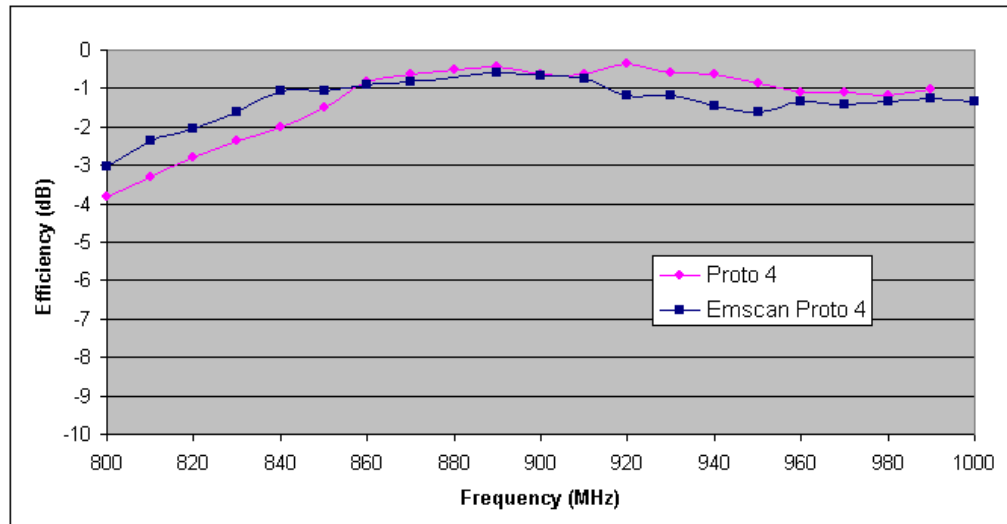
Note: Low band offset applied by customer

Mobile Phone Efficiency



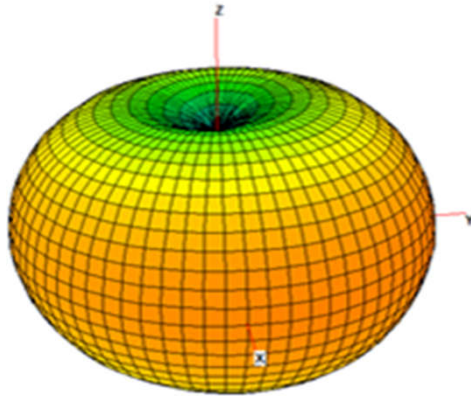
Note: Low band offset applied by customer

Mobile Phone Efficiency

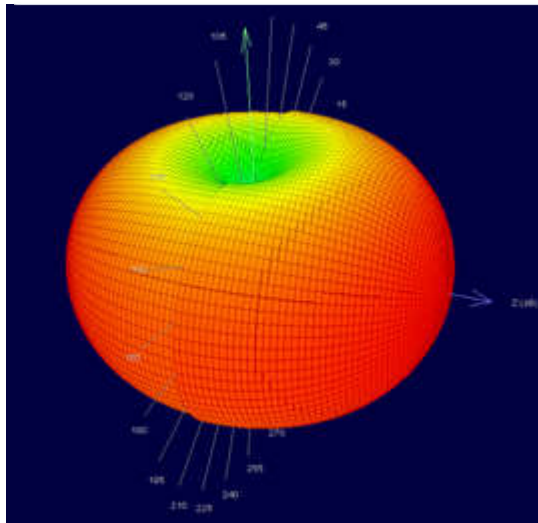
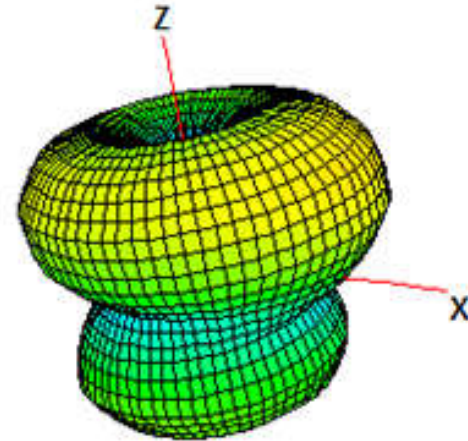


Note: Low band offset applied by customer

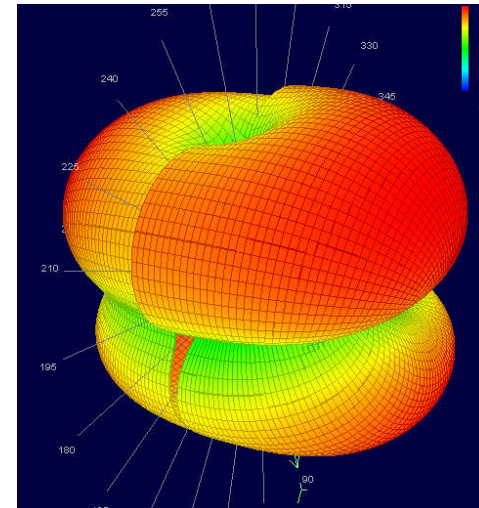
Patterns of Various Mobile Phones



CTIA

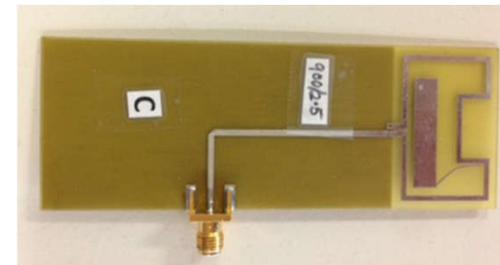
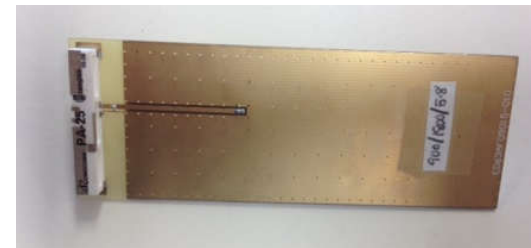


RFxpert



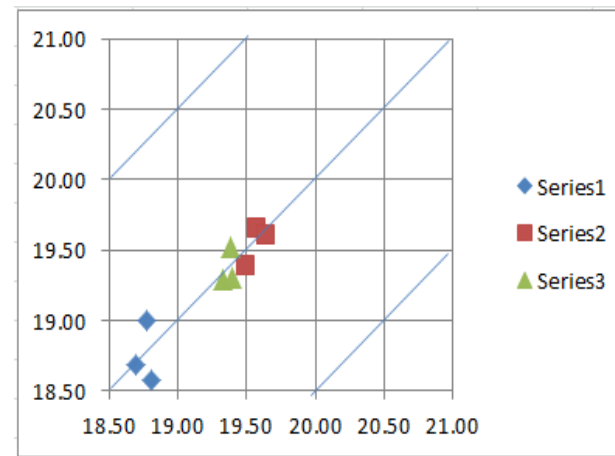
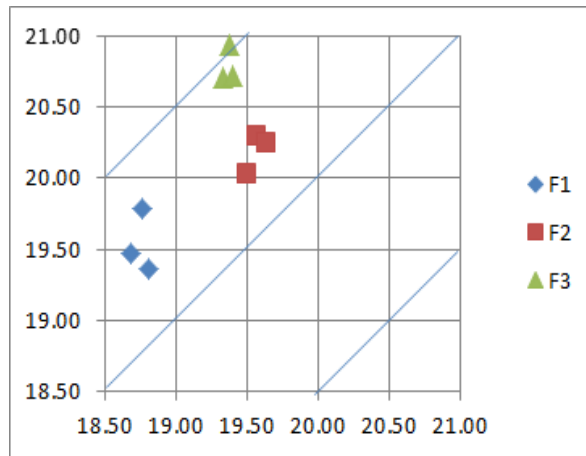
Passive Antenna Results

- 47 antennas measured in CTIA MVG Satimo chamber
 - 20 PIFAs, 10 Patch designed by EMSCAN
 - 17 acquired antennas are a mix of different sorts



PRAD Offset Table

● Re-alignment process



Band 5					
Freq 1	Chamber	EMSCAN	Error	Applied Error	Adjusted
1	18.81	19.36	-0.55	-0.78	18.58
1	18.77	19.78	-1.01	-0.78	19.00
1	18.69	19.47	-0.78	-0.78	18.69
2	19.49	20.04	-0.55	-0.64	19.40
2	19.56	20.30	-0.74	-0.64	19.66
2	19.63	20.26	-0.63	-0.64	19.62
3	19.33	20.71	-1.38	-1.42	19.29
3	19.40	20.72	-1.32	-1.42	19.30
3	19.38	20.93	-1.55	-1.42	19.51

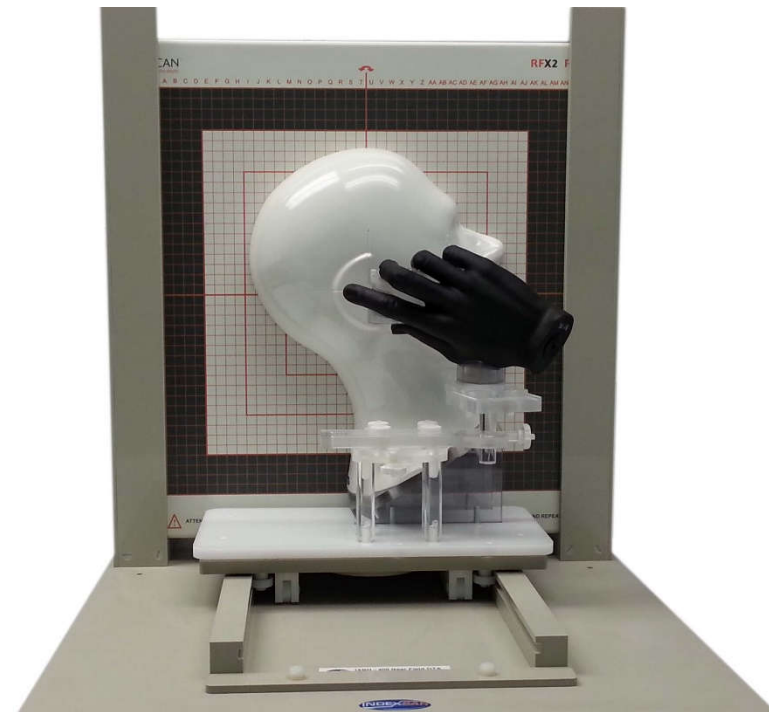
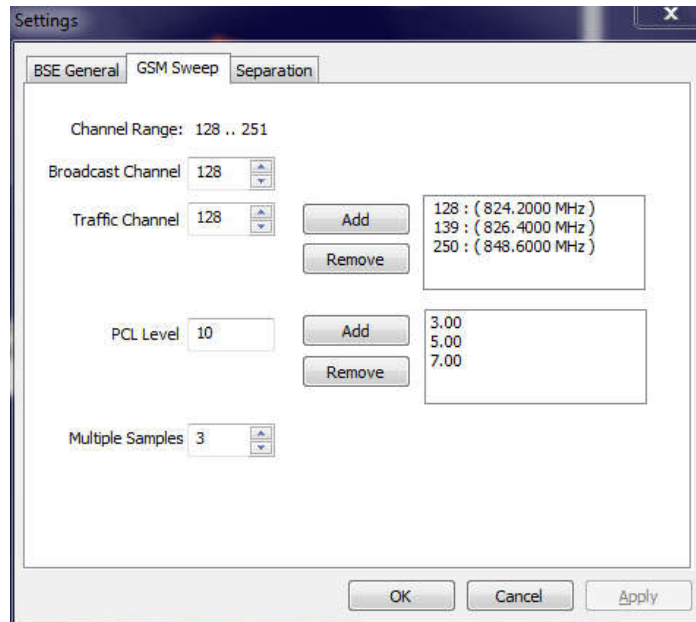


RFxpert

Test Applications

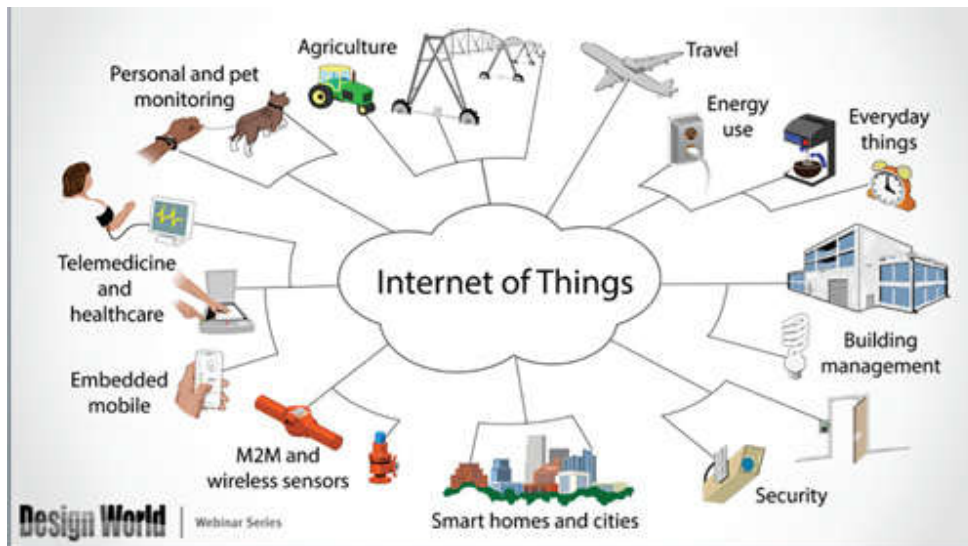
Cellular Phone

- Power and pattern measurements at a single channel or a series of channels through the remote control of a Base Station Emulator

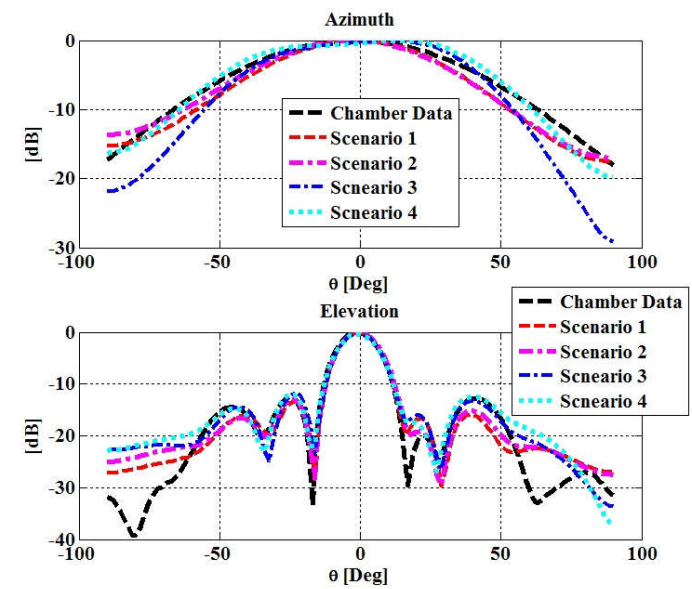
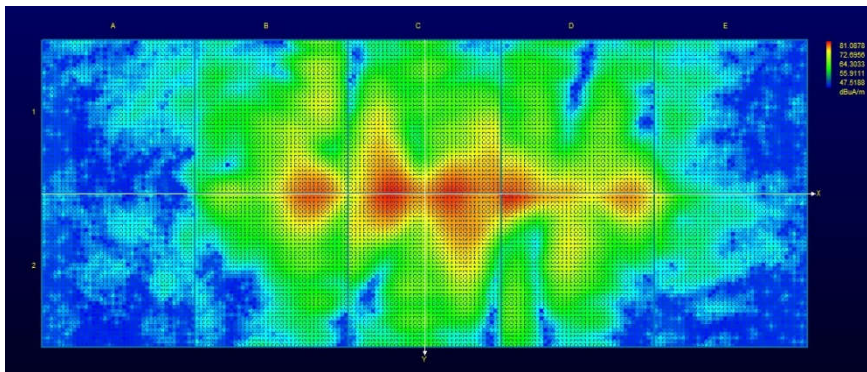
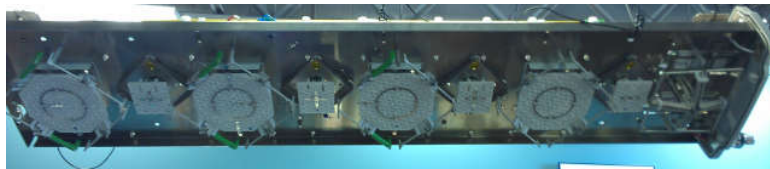


IoT

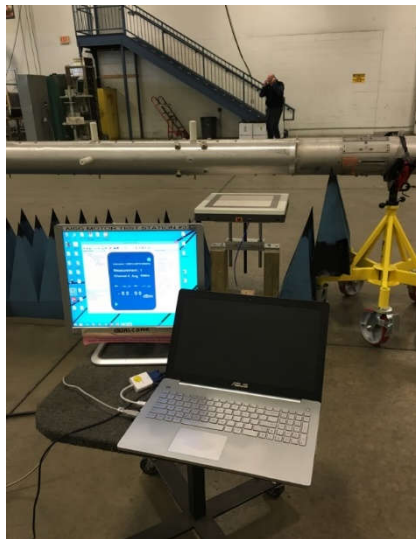
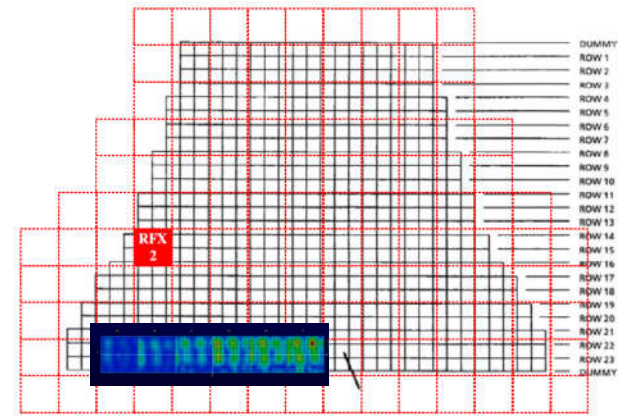
- Fast pre-certification



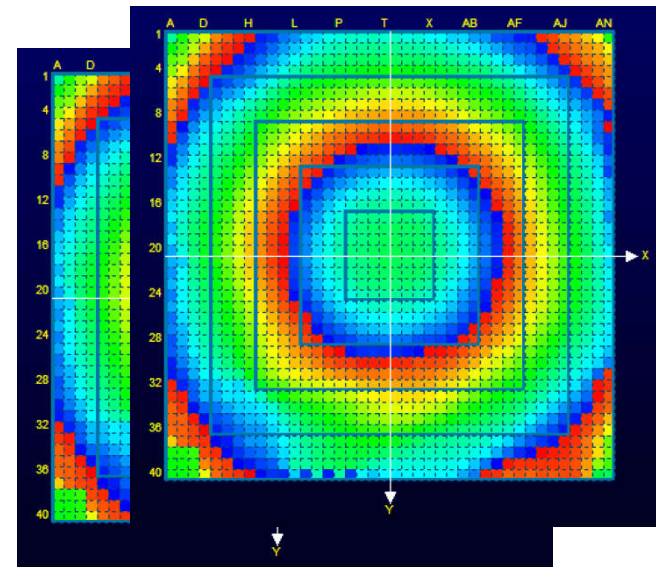
Cellular Base Station Antenna



Testing of Large or Long Antennas



Phase Center



Wi-Fi

- Any customized pulse up to 60-second timeout

Scan Settings Modulation Settings Separation Select scan range

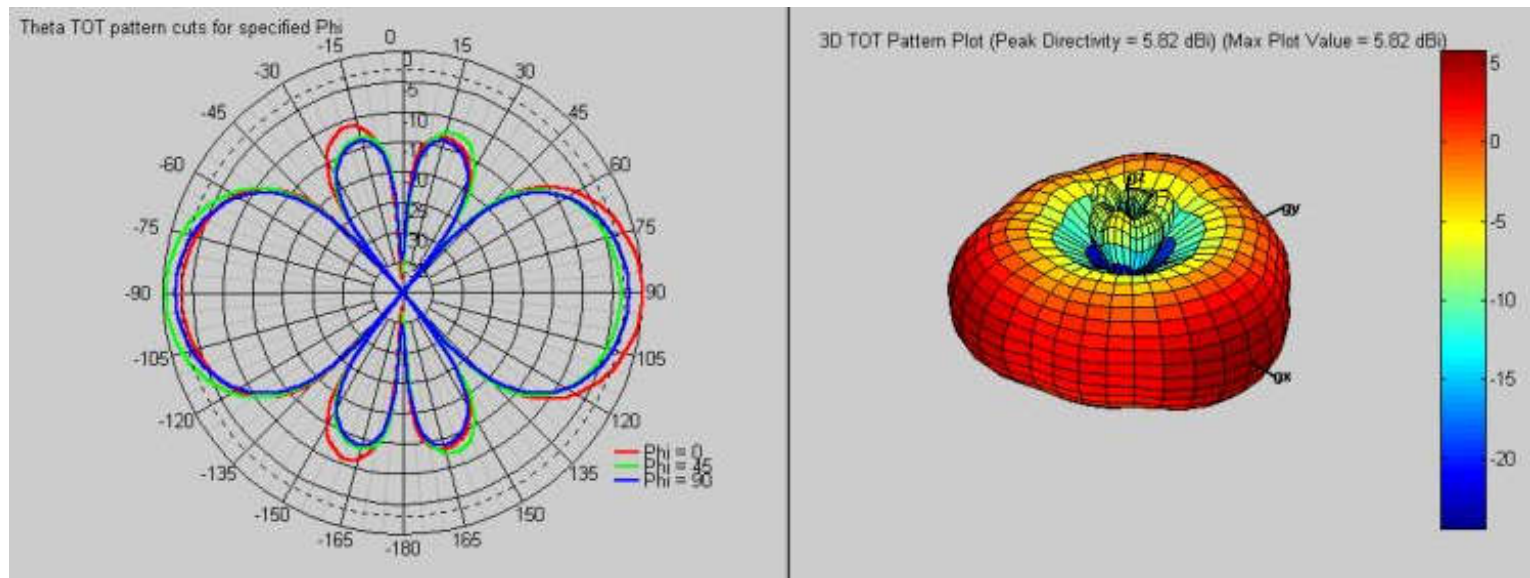
CW/CDMA
 Bursty/TDMA/etc
 Advanced

Advanced Setting

Timeout	<input type="text" value="50"/>	ms (10 to 60,000)
Threshold	<input type="text" value="-55.94"/>	dBm (-70 to -30)
Holdoff	<input type="text" value="10"/>	μs (5 to 50)

Phased Array Antenna

- Phase balancing



Picture from www.mathworks.com/

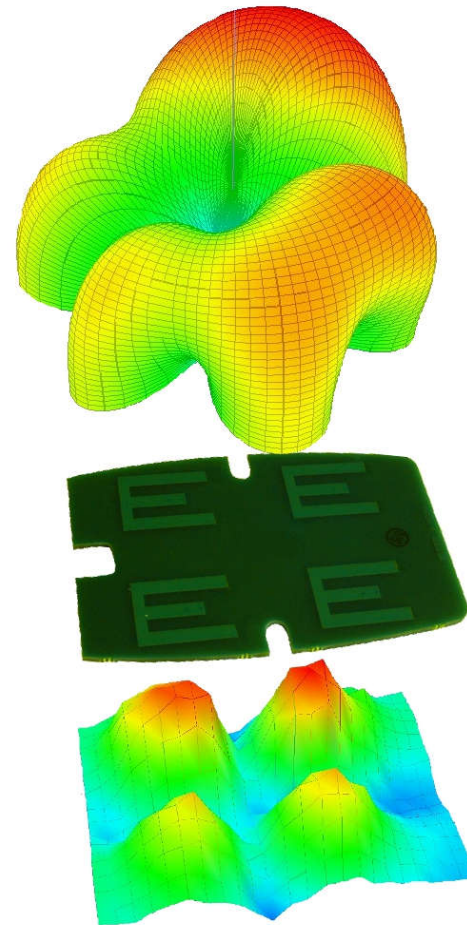
GPS Antenna

- Circular Polarization



MIMO

- **Very-near-field for antenna diversity and mutual coupling**
- **Far-field for real-time tuning**
- **Correlation**
 - Envelope and pattern correlation
 - Hemispherical RFX
 - Spherical RFX2



Smart Meters

- **Connectivity with**
 - GSM, Mobile
 - WLAN / WiFi
 - ZigBee
 - M-Bus
 - Custom
 - Others ...
- **Measurement of antennas**
- **Measuring active device with long timeout**



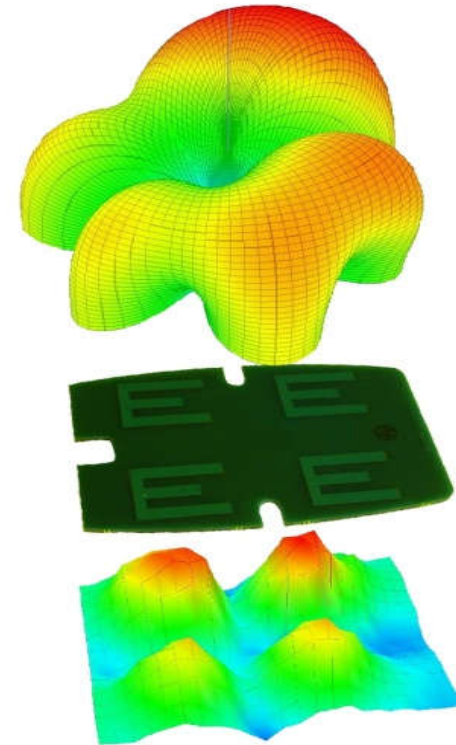
Figure 2-3
Cell relay meter with flexible, dual band (850 MHz and 1900 MHz) antenna affixed to interior surface of the meter cover.

RFxpert

Conclusion

Very-Near-Field Benefits

- Ability to see surface currents
- Very fast scanning
- Repeatable
- No chamber
- Low maintenance
- Easy to use



RFxpert Advantages

- **Interaction effects in real-time**
- **Very-near-field measurements**
- **Fast and repeatable**
- **Low CAPEX**

Some Customers



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